PRELIMINARY DRAFT

Measuring the Diffusion of Innovation: A Reassessment of Knowledge Spillovers Using Machine Learning

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Abstract

The ideas of new invention are encapsulated in the text of a patent. Empirical measures of knowledge flows have previously relied on citations, which are the inputs or influences behind new ideas, not the ideas themselves. I use recently developed Machine Learning/Natural Language Processing methods to convert patent abstracts (which are descriptions of the invention) to vectors and analyse the similarity across inventions. Unlike most of the citations-spillovers literature, I find that geographic localization effects are insignificant to modest: prior to controlling technological proximity, within technology field patents from the same city are about 0-0.08 standard deviations more similar than patents from different cities. Including further technology controls reduces estimates to -0.02 to 0.04. By contrast, citations based measures find that local patents have 0.24-0.34 standard deviations more citations from the same city compared to a non-local control. These findings suggest that significant localization in innovation inputs may not translate to the same effect in outputs.

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1. Introduction

Knowledge spillovers are considered a key driving force of endogenous growth. A prominent literature of measuring knowledge spillovers has emerged from Jaffe et al. (1993) (henceforth JTH) that uses patent citations to study the "paper trail" left by the diffusion of innovative knowledge. The widely held consensus is that knowledge spillovers are geographically localized, meaning that local inventors and firms benefit more from the positive externalities generated by the R&D of other local firms, compared to inventors and firms located in different cities. However, citations are not the product from the innovative process as they do not represent the ideas within inventions. Until recently, no viable alternatives have emerged in the study of spillovers outside of using citations.

This paper utilizes methodology made available by advances in Machine Learning/NLP to analyze the ideas within inventions as embodied by the patent abstract, which summarizes the invention. I make three key contributions: first, I derive vector representations of innovative ideas using Document Vectors (DocVec) and Latent Dirichlet Allocation (LDA). Second, I extend the original research of JTH as a benchmark measure, and find that the citations based measures of geographic localization are large, significant, and growing over time. Third, I use cross-patent similarity within technology fields to measure if patents from the same city are more similar than those from differing cities. I find that localization is insignificant to modest, and has declined in recent years. Including finer controls for the pre-existing technological proximity across patents further dampens the size of the estimate, and even slightly negative in some cases.

My findings imply that high levels of geographic localization in the influences or inputs to the innovation process (as represented by citations) may not imply that innovation *outputs* are highly localized. In the context of intellectual property, the scope and value of a patent is directly related to how novel it is to related inventions. Knowing more about local inventions may, in fact, induce firms to *distance* their inventions from their local rivals. I find that when patent pairs are from highly similar technology subfields, they are more distant (i.e. less similar) if both originate from the same city on average. This phenomena of local differentiation in innovation outputs may be related to the product market rivalry effect from Bloom et al. (2013). The exclusive use of citations may not be able to capture this effect.

There are also well-documented concerns that citations themselves may be somewhat exogenous to the innovation process. Cotropia et al. (2013) and Alcacer et al. (2009) detail the extent to which patent examiners add their own citations they consider to be relevant prior art for the invention. Lampe (2012) and Roach and Cohen (2013) find that citations are made strategically in ways that do not reveal knowledge

flows, at least to other firms' privately held patents. While examiner added citations muddy the waters of what exactly citations represent, they do not necessarily have direct implications for localization. On the other hand, I find evidence that firms under-cite highly relevant patents from other cities, and over-cite less relevant patents from their own cities (section 3.1).

The strategic incentives that may overstate localization are twofold: first, that firms want to protect the scope of their inventions and thus leave out related citations that they may be "reasonably ignorant" of; second, local firms may be more apt to discover potential infringements. I investigate the first possibility by examining inventors' self-citation rates before and after they change firms. I find that inventors consistently cite their own prior inventions less after shifting firms, particular for relatively highly similar previous patents, but that this gap closes for the most similar bracket.

In measuring geographic localization using patent and citation data 1976-2015, I compare the results of four approaches. Each follows the same regression function, but with alterations to the knowledge spillover measure and what technology controls are included. I normalize each of the measures so that the estimate of the localization effect $(\hat{\beta}_1)$ may be comparable.

$$KS_{i,j} = \beta_0 + \beta_1 I(MSA_i = MSA_j) + Technology Controls + \epsilon$$
 (1.1)

First, a straightforward extension of JTH's methodology finds large and significant effects of localization: local patents have 0.24-0.34 standard deviations more citations from the same city compared to a non-local control from the same USPTO primary classification. Second, I use the same sample of patents and citations and instead measure the difference in the similarity of local citations to non-local citations. I find that local (forward) citations are on average 0-0.05 standard deviations more similar to the cited patent than non-local citations. Third, abstracting from citation relationships, I look at the cross patent similarity between patent pairs within the same technology field: (i) within NAICS industry; (ii) within primary class. I find that local patents are 0.02-0.06 standard deviations more similar than non-local patents for within-industry patents; the localization estimate increases to 0.05-0.08 for within-primary class patents. This implies that spillovers for innovation outputs may be higher for more specialized technogy fields over broader measures.

The robustness of the previous results may depend on whether or not selecting from the same technology field is enough to account for technological proximity. In the fourth approach, I add finer controls for pre-existing technological similarity between within-NAICS random patents by using (i) the similarity between

their primary classes; (ii) the similarity between their city-specific primary classes. Under (i), localization estimates remain close to their levels without controls, while under (ii), the estimates diminish to around -0.02; meaning that after accounting for the similarity in a patent pairs' city-specific technology subfield, local patent pairs are slightly less similar than non local pairs on average.

To see how localized knowledge flows respond to shocks to the patent stock, I examine expansions in innovation caused by legislation and court decisions. I look at the time series of average localization estimates to (i) university patents pre and post Bayh-Dole Act (1980); (ii) nanotechnology patents pre and post the National Nanotechnology Initiative in 2000; (iii) the spate of court decisions in 1994 that liberalised the patentability of software. I find that while there is a significant decline in localization at the time of the two legislative changes, due to the shock of new innovation, there was no significant jump afterwards. This suggests that new knowledge does not necessarily generate positive externality gains to local firms and inventors first.

Finally, I examine the notion that localization induces greater concentration of innovation in places where the local spillover effects are highest. I find that local spillovers (both similarities and citations) do not explain any variation in how much a city dominates new innovation in a technology field. In fact, the more distant (and thus "novel") a city's previous innovation in that field was, the more likely they are to have higher future innovation growth within that field. This indicates that a city's ability to produce novel innovations relative to other locations determines its future capacity for innovation, not the size of its local knowledge spillovers. I conclude by discussing the implications of my findings for R&D policy and future research.

The paper proceeds as follows. Section 2 discusses the previous literature, data sources, and outlines the NLP methodology. Section 3 assesses citation patterns when examined in conjunction with cross-patent similarity. Section 4 presents the estimation models and results for localization regressions. The dynamics of localization following exogenous shocks to innovation is discussed in section 5. Section 6 examines the relationship between local knowledge spillovers and local innovation growth.

2. Previous Literature and Data Construction

2.1. Previous Literature

Knowledge spillovers are widely believed to be one of the key contributors to the phenomena of agglomeration. In October 2017, Amazon lead a widely covered search for a location for their second headquarters. Motivating all 238 cities vying for such an opportunity was the promise of agglomeration, the benefits accruing from the proximity of workers and firms clustering in the same location. Krugman (1991) and Marshall and Marshall (1920) cite knowledge spillovers as a source of positive externality, but not necessarily confined to cities themselves. The localized nature of knowledge spillovers (i.e. the spread of knowledge is bounded within a geographic region) has been argued by Jacobs (1969), Manski (2000) and Glaeser et al. (1992), who observe that "intellectual breakthroughs must cross hallways and streets more easily than oceans and continents." Feldman (1994) motivates this by suggesting that firms in the same location reduce the uncertainty of innovation by sharing knowledge.

This is further complicated by the fact that location is also a strategic choice for firms. As Alcacer and Chung (2007) point out, firms may favor locations rich with knowledge sources. Thus, location is an endogenous choice. Bloom et al. (2013) also note that product market rivalry exists across firms, which may serve to dampen spillover effects. However, they find that the importance of technology spillovers outweigh rivalry effects.

The empirical knowledge spillovers literature began with Jaffe et al. (1993). JTH examines whether or not inventors are more likely to cite patents closer to them, compared with a control patent. *To* separate localization effects from the existing distribution of patenting activity across locations, JTH select a control patent from the same technology distribution using PTO classes. They argue that since patents from the same PTO class come from the same technology distribution, then if there were no localization effects, there would not be significant differences in their citations' distribution across locations. Their study finds highly significant localization effects using the control/treatment methodology.

There are three main concerns with their methodology: first, whether or not their control selection method (using PTO primary class) is appropriate. Thompson and Fox-Kean (2005) use PTO primary subclass and find less significant localization effects; Murata et al. (2014) draw counterfactuals from a distribution, and alongside Buzard et al. (2016), use a continuous distance measure. Both papers find substantial evidence supporting localization. Instead of drawing counterfactual patents from PTO classes, another strand of literature uses the geographic mobility of inventors and authors to identify local spillover

effects. Almeida and Kogut (1999), Agrawal et al. (2006), and Azoulay et al. (2011) all find that citations located in the inventor's or author's previous location is much higher than the control's citation rate. (These studies do still use the control/treatment method, just with stayers/movers) However, this does not address the second concern: that location choice cannot be taken as exogenous. As highlighted by Alcacer and Chung (2007), firms are strategic in their choice of location and may choose location based on where local spillover effects may be strong. Greenstone et al. (2010) directly address this by using "Million Dollar Plants" data to compare the agglomeration spillover effects in "winner" counties that were chosen as well as "runner-up" counties who narrowly lost, who serve as counterfactuals. They find evidence in favor of local TFP spillovers, though not directly addressing shared knowledge. Spatial econometrics have also been applied in addressing geographic localization. Following Bloom et al. (2013), Lychagin et al. (2016) find significant positive localization effects of technological proximity using vectorizations of PTO classes.

Machine Learning and Patent Text Analysis

In order to address these concerns, I propose using a different measure of spillovers. Jaffe (1986) and Bloom et al. (2013) both use cosine similarity across technology space to proxy for spillovers, representing patents as a vector in PTO classes space. Recent developments in text analysis and machine learning have provided numerous methods of converting text into vector space representations. Instead of using just one Machine Learning method, I will use three: Neural Networks, Topic Models, and Document Vectors. Each of the three methods have enjoyed very recent popularity within the Machine Learning and Natural Language Processing communities (for a recent discussion, see Campr and Ježek (2015)).

Due to the nascency of such methods, there is fairly scant literature directly applying Natural Language Processing methods to patents, and none directly applying such methods towards measuring knowledge spillovers. There exists a micro-literature that uses semantic-based Machine Learning methods to analyse patents (Tang et al. (2012)) and come up with alternative classification systems to the PTO class system (Bergeaud et al. (2017)). Kaplan and Vakili (2015) directly applies topic models to a subset of patents within the nanotechnology class in order to measure breakthrough innovation. (Will return to expand here)

2.2. Data Sources

Patent data is taken from PatentsView on all utility patents granted 1976-2016, containing data both on inventors (including unique identifiers and location) and patents (assignee, application date, grant date,

primary class and subclass). Bibliographic text data is taken from the USPTO Bulk Data Products, which has all patent bibliographic text from 1976 to end of 2015. Patent abstracts are taken to be representative of the knowledge contained in patents, as they are a summary of the invention.

Patent technology fields

Each patent is assigned three technological *fields*, with each field being nested in the previous. At the broadest level, an NAICS-based industry classification is given using the USPC to NAICS concordance crosswalk, which delegates each patent to a NAICS category according to its USPTO 3-digit primary classification. Additionally, many patents are also assigned a primary *sub*class.¹ Primary subclasses are nested in primary classes, which are in turn nested in a NAICS industry label. There are over 150,000 subclass labels; 450 class labels, and 33 NAICS industry labels.

2.3. Patent Abstracts to Vector Space Representations

Using patent abstract texts, I use procedures standard in the NLP literature to clean and convert text to vector representations. I select two unsupervised algorithms (Latent Dirichlet Allocation and Document Vectors) for the conversion process that are most appropriate for the task at hand: to convert a large quantity of texts into meaningful vectors that allow for sensible cross-comparisons of the represented knowledge. LDA has received considerable attention in a wide variety of literatures, and has been applied to patents by Kaplan and Vakili (2015). Document Vectors is a relatively more recent technique that has performed very well in providing sensible results as deemed by human judgment. (TODO cite) For a survey of the literature, see (TODO cite).

2.3.1. Unsupervised Machine Learning Methods: Topic Models

Latent Dirichlet Allocation, first introduced by Blei et al. (2003), is a method of Topic Modelling that assumes that a document can be represented as a linear distribution hidden variables called *topics*. It is a Hierarchical Bayesian hidden variables model. The Data Generating Process assumes that each topic is a linear distribution over terms in the corpus. For each document, which is a distribution over topics, each term is assumed to be generated by first drawing a topic, then drawing a term from that topic. Because this is an unsueprvised method, the algorithm then jointly determines the topics distribution over terms

¹Patents may also include other discretionary classifications, which are not used in my data.

Topic	Distribution over terms	Description
0	0.040 *" network" + 0.039 *" inform" + 0.033 *" comput" + 0.031 *" communic" + 0.028 *" user" + 0.027 *" memori"	Networks & Coding
2	0.066*"time" $+ 0.057*$ "sensor" $+ 0.040*$ "detect" $+ 0.032*$ "event" $+ 0.031*$ "paramet" $+ 0.027*$ "level"	Monitoring & Coding
11	0.116*"power" + 0.068 *"voltag" + 0.049 *"output" + 0.045 *"circuit" + 0.026 *"suppli" + 0.026 *"transistor"	Electronics
36	0.071*"composit" $+0.059*$ "polym" $+0.049*$ "weight" $+0.041*$ "coat" $+0.018*$ "resin" $+0.016*$ "c"	Polymers, Chemicals
53	"0.065*" metal" + 0.065*" solut" + 0.037*" ion" + 0.036*" carbon" + 0.032*" concentr" + 0.023*" reaction"	Metals, Chemicals

Table 2.1: Selected Topics as outputted by LDA. Description added post hoc.

Figure 2.1: Example of a patent converted into a distribution over topics.

0.49 x topic 0 + 0.12 x topic 1 + 0.10 topic 2 + 0.07 x topic 51 + ...

and each document's distribution over topics. See A.1.2 for more details on the assumptions of the LDA model.

The number of topics K is a parameter that is determined ex-ante; as per Hoffman et al. (2010), the recommendation is that the model with the lowest log perplexity be selected, although there is not a universally agreed upon procedure. I fit a LDA model on a training subset of the same document-term matrix representing all patent abstracts with 20, 30, ..., 120 topics. Then, the model was fit on the test set and the log-perplexity calculated. I selected K=60 as it had the lowest log perplexity across the models.

A snippet from the resulting topics is shown in 2.1, alongside the six highest probability terms in teach topic. The output I am interested in is the probability across each of the 60 topics of each patent document. I take this as the Topic Model vector representation of each patent.

2.3.2. Unsupervised Machine Learning Methods: Document Vectors

Document Vectors was introduced by Le and Mikolov (2014), and is a straightforward extension of the word2vec model of Mikolov et al. (2013b,a). Word2vec was developed in order to address issues with the bag-of-words procedure, primarily the loss of information provided by word ordering, and its inability to identify similar terms. To address this, word2vec uses the "context" around each term in the document in order to represent a term in vector space. For example, for the sentence "Provides for unattended file

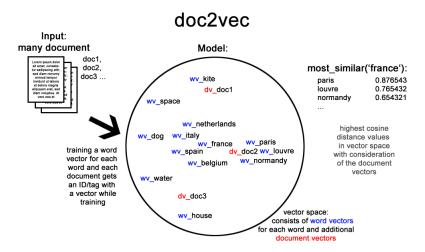


Figure 2.2: Illustration of Document Vectors. (Will redo with specific reference to my work)

transfers", the word "unattended" has the context ["Provides", "for", "file", "transfers"]. Every word and document is assigned a vector of dimension $N=100.^2$ The resulting vector places words that arise in similar contexts close to each other. Since documents are treated more or less just like words, the algorithm places documents that contain similar terms close to each other in the vector space. See A.1.1 for more details on the algorithm.

The main difference between Document Vectors and other representations is that the columns of the vectors do not represent anything meaningful; its purpose is solely to find a way to place documents in a vector space such that distances across the vectors represent similarity across patents as detected by the algorithm.

2.4. Measuring Knowledge Spillovers: Cross Patent Similarity

Cosine similarity ³ has been used to measure technological proximity in Jaffe (1989) and Bloom et al. (2013), as well as being standard in the NLP literature (Mihalcea et al. (2006)). The primary advantage of NLP patent vector outputs is that they are *jointly* determined, and position each patent vector *relative* to all other patents within the corpus. Thus, cross-patent comparisons using NLP vector outputs are much more internally consistent.

For two patents, i and j, the cosine similarity between them is:

$$sim(i,j) = \frac{PV_i \cdot PV_j}{\|PV_i\| \|PV_j\|}$$
 (2.1)

²This is a rule-of-thumb in the literature, according to Lin et al. (2015)

³Other measures, such as Hellinger distance, were also used but found to be very highly correlated with cosine similarity.

Where PV_i is the patent vector representation of i. This is preferred to Euclidean distance as it is factors in the "size" of the vector; a Euclidean distance measure would assign positive distance to two vectors that contained the exact same words, but of different quantities. Cosine similarity normalises all measures to be in the range [-1,1].

2.4.1. Technology Controls: Cross Field Similarity

Since each patent is assigned technology field labels, the vector representation of a technology field f at t can be the $median^4$ of all patents within the field granted from year t-5 to t:

$$FV_{f,t} = median(PV_i|i \in f)_{t-5,t}$$
(2.2)

Further, I can treat the fields at each location as a "sub"-field, and define a location field vector at some MSA l as:

$$LFV_{f,l,t} = median(PV_i|i \in f, i \in l)_{t-5,t}$$
(2.3)

For LDA, this represents the distribution of all patents in the field across each of the 60 topics. For Document Vectors, this represents the centroid of the set of all patents within the field. For any patent i in field f_i , cross-field similarity and cross-location-field similarity to patent j is analogously:

$$sim(f_i, f_j) = \frac{FV_{f_i} \cdot FV_{f_j}}{\|FV_{f_i}\| \|FV_{f_j}\|}$$
 (2.4)

Intuitively, this is the *expected* similarity between two patents if only their technology field was known. Cross field similarity are analogous to the technological proximity measures of Jaffe (1986); Bloom et al. (2013). Both papers, alongside other citations-based methods of measuring technological proximity, rely on the vectorization of PTO classes. These methods may lead to inconsistent results as each patent may have any number of non-primary classifications. The standard procedure has been to normalize or weight each of the classes listed, which discretizes the vector space and leads to discontinuities in the proximity measures.⁵

⁴The median is chosen as a better representation of the field as it is less sensitive to outlier values.

⁵A patent with one class would be represented by a vector with 1 in the class column and 0 elsewhere; two classes 0.5 in each class column and elsewhere; and so on.

2.4.2. Comparing LDAVecs and DocVecs in Measuring Document Similarity

TODO - will be examples, looking at where they differ, what they do well and not so well

2.5. General Trends in Innovation

U.S. patents granted 1976-2015 are primary dominated by five main industries: Machinery (15.8%), Computer and Peripheral Equipment (11.4%), Semiconductors (9.3%), Navigational and other Instruments (9.1%), Communications Equipment (7.7%). Following more general trends in U.S. manufacturing, the pattern as time progresses has been the shift from Machinery related innovations to Computer related innovations. The cities dominating innovation have also shifted from the east coast to the west, particularly San Jose and San Francisco.

In terms of agglomeration, we may also be be interested in the concentration of innovation across various cities over time. Following Moser (2011), I use the Herfindahl index (HHI), which is commonly used to calculate market power, to examine the city-concentration of innovation within industries. I find that, in general, HHI declined from 1975-1995 before rising again 1995-2015 (figure C.1). In 2015, there was a sharp upward trend in city-concentration across a range of industries. In the Semiconductors industry, which I examine more closely in section §5, there is a noticeable incline in HHI 1990-2000. This may be due to the entry of new innovation in the field which is initially concentrated, then diffuses more widely through the economy. This U-shaped trend is also mirrored when looking at the HHI of *industry*-concentration over time (figure C.2): the decline in concentration of innovation within few industries is reversed around 1995, and has been rising steadily ever since.

This pattern also emerges in the within-industry similarity trend (figure C.3). However in the case of similarity, there is not a pronounced initial downward trend. The turning point here is around 1990, meaning that after 1990, patents within industries began to look more similar to one another. While this fact alone is not necessarily a cause of concern, combined with the growing city-concentration, these trends may indicate a decline in the diversity of innovation: as inventions in smaller cities decline, the new inventions from already concentrated centers dominate and industry patents look more alike. Additionally, note that the turning point for similarity occurs a few years prior to the turning point for city-concentration HHI. We may speculate that the rise in overall similarity, meaning a fall in overall difference, may be a preceding symptom of declines in innovativeness across smaller locations.

3. Comparing citations and similarity as measures of spillovers

The validity of citations as a measure of knowledge spillovers are challenged by the existing literature. It has been widely used in practice because, until now, another such measure has not been available. I argue that patent vector similarity is able to bypass the more damaging criticisms of citations, insofar as it does *not* reflect strategic considerations on the part of the applicant. Because patent abstracts must be accurate summaries of the invention at hand, this limits the ability of applicants to omit important technological terms in order to hide the relevance of previous knowledge. ⁶ Theoretically, it is difficult to imagine inventors internalizing the similarity of the text within their patent to all other patents in the corpus when choosing words to describe their invention.

The problems with using patent citations to proxy for knowledge flows have been well documented. The two dominant concerns are: (i) many citations added by external agents (either law firms or patent examiners), which obfuscates the relationship between the patent and citation as a direct knowledge "flow"; (ii) there are strategic reasons for withholding relevant citations. Namely, citing patents that are closely proximate to the invention limits the scope of the patent and thus reduces the value of the intellectual property. These effects can result in substantial measurement error: Alcacer and Gittelman (2006) find that on the average patent, two-thirds of citations are added by the examiner, while Cotropia et al. (2013) find that applicant citations are often ignored by examiners who conduct their own search of prior art. Citations are also strategic in that, according to Jaffe and De Rassenfosse (2017), "although applicants at the USPTO have a duty to disclose what they know, they have no duty to search for prior art and may be better off by remaining ignorant." Inventors seeking to maximise the value of their IP may be inclined to leave out the most relevant citations; Lampe (2012) finds that applicants withhold between 21% to 33% of relevant citations, as determined by the applicant firm's previous citations. Using a survey of lab managers, Roach and Cohen (2013) also find that patent citations are more reflective of a firm's appropriability strategies in ways that are not revealing of "true" knowledge flows.

A more nuanced challenge is in the assessment of which measure is a better proxy for knowledge spillovers. Similarity should not be taken as a replacement for citation measures. While citation measures are discrete, indicating the occurrence of a "direct" flow of knowledge, patent similarity measures are continuous between [0,1]. Theoretically, we can think of patent knowledge outputs as a function of knowledge inputs. In this case, patent text would represent outputs and the citations of a patent would represent some of its input.

⁶Legal considerations could still affect the choice of words used in patents.

If patent p_j cites p_i , this should ideally indicate that p_i was in the set of knowledge inputs for p_j . We can think of $sim(p_i, p_j)$ as indicating how proximate the knowledge outputs of the two patents are, without necessarily indicating if p_i is in the input set for p_j . While this means that similarity is suboptimal as a measure of direct knowledge flow, it may be a superior measure for knowledge spillovers, which is an externality to the knowledge production process. Finding the effects on knowledge production that are indirect might be better suited for the task of proxying for spillovers. Since we have not had an alternative to measuring spillovers until this point, the theoretical case for which measure is better suited for the task remains to be determined and is beyond the scope of this paper.

3.1. Using similarity to determine trends in the relevance of citations

The incentives of the inventors in making citations are two-fold: firstly, to offset the likelihood of patent litigation (which rose sharply in 1990-2010); secondly, to maximise the scope of the patent by not making citations that may challenge the novelty of the invention.

In line with the first incentive, it has been well documented that the number of citations made by each new patent has been rising dramatically over time. I construct a sample comprised of all citation patent pairs (CPP, comprised of a cited patent and a forward citing patent granted within 10 years of the cited patent) with self-citations made by the same assignee removed. From 1985 to 2015, the average number of citations made by each patent rose from 2.3 to 6.0 (B.1). This trend is accompanied by evidence that this phenomena has reduced the relevance of the citations, and thus the quality of citations as measure of spillovers. I find that the proportion of citations made to patents within the same primary class has declined sharply, from 54.1% to 34.4%. While this fact alone is not decisive (as it may indicate greater inter-field influences) there has also been decline in the average DocVecs similarity of the citation to the cited patent, from 0.28 to 0.25 (B.4). This decline persists even for citations made within the same technological field (B.5). Taken together, these trends would indicate that the relevance of citations have been diluted by the addition of less related citations. However those made to patents within the same MSA has increased, although not consistently over the period: the share of local citations rose from 9.3% in 1985 to 12% in 2015. A possible explanation for this trend may be that other local inventors are more likely to discover potential patent infringements, and thus the risk of patent litigation may be higher for local firms than non-local.

To explore this possibility, I construct a different sample of "potentially citable" patent pairs (PCPP): I sample a set of patents (target patents, tp), and find patents they cite from the sample CPP. I then find all

other patents (op) granted after the target tp that also cite those patents, and pair them with the target patents. (See B.1 for complete outline of all sampling procedures) The idea is that if op cited the same patents as tp, then it is plausible that the two patents are related enough that op might also cite tp. I then calculate the similarity of all pairs in this sample, and find the conditional mean of the rates of direct citation between op and tp for each similarity bin. Over 2.4 million pairs of similarities are calculated. To prevent noise from bins with few observations⁷, the lowest bin includes all values below, and the highest bin includes all values above. Hypothetically, we should have a number of expectations if the incentive to leave out relevant patents strategically are weak:

- 1. The rate of direct citation should monotonically increase with the similarity between the two patents.
- 2. Rates of citation should be generally higher for patent pairs within the same location or technological field, as inventors are more likely to be familiar with other inventions close to them.
- Rates of direct citation should be higher for primary class, as we should also expect inventors to be more familiar with patents in the same narrower band of technology field over the broader categorisation of NAICS.
- 4. If location does not bear any additional consideration on citations, then we should expect overall shape of the trends for local pairs vs non-local pairs to look like that of patent pairs in the same vs different technological fields.

I find evidence in support of (2) and (3), but against (1) and (4) (see figure 3.1). The rate of direct citation is *not* monotonically increasing with similarity, and in fact *declines* at the highest bracket of similarity. Overall, while 6.3% of tp patents are directly cited by op when their similarity ranges between 0.5-0.6, only 4.2% are cited for similarity 0.6-0.7+ (represented by the bin 0.7). This trend holds for patent pairs within the same technology field. Rates of citation were found to be higher for pairs from the same technological field over differing fields (supporting (2)) and from the same primary class over the same NAICS (supporting (3)), although that advantage faded as similarity grew.

Most interestingly, for pairs from the same location, there is an immense divergence in the citation rate for highly similar pairs (0.6-0.7+): 7.5% for 7163 local pairs and 2.2% for 11795 non-local pairs (see table B.1). In fact, patent pairs in the same location were the only group that behaved according to (1), implying that there are substantially weaker incentives to withhold highly relevant citations from the same

⁷Below the 1st percentile and above the 99th

location, compared to citations from different locations. Additionally, the rate of citation catches up for non-local to local patents when similarity is relatively high (0.4-0.6), ⁸ before sharply diverging. We would expect in the absence of strategic incentives that the rate of citation would meet at high levels of similarity and *not* diverge. The fact that these patterns look different to the patterns for technology fields (against (4)) further suggests that location *does* bear separate consideration when inventors make citation decisions, particularly for highly relevant patents.

Since local inventors are much less likely to withhold relevant citations to other local patents, these results support the notion that localization in citations may be driven by strategic behaviour on the part of inventors. To get a sense of the scale of the problem, as a counterfactual exercise, suppose inventors cited non-local patents at the same rate as they did local patents, conditional on similarity. This would imply a total of 53993 citations, compared to the actual figure of 41449. This implies that approximately 30% of non-local citations are "missing."

3.2. Inventor mobility and rate of citation for their own previous work

A clear example of where strategic non-citation might emerge is in the rate of citation for inventor's own patents, once they move to a different firm. Since inventors cannot reasonably claim to be ignorant of their own inventions, we can safely assume that any discrepancies in the rate of citation must be attributed to strategic withholding on the part of the new firm. I compare the rate of inventor self-citation when they are at their first firm, to the rate of self-citation of patents at their second firm to the patents at their first firm. Suppose inventor i has patents A, B, C at firm 1, and D, E at firm 2. Then I will compare the self-citation rates in the set AB, AC, BC before their firm change, and AD, AE, BD, BE, CD, CE after the change. Since inventors often work in slightly different areas at their new firm, it is also crucial to condition on pairwise similarity in order to ascertain the appropriate benchmark citation rate. I use all 12,377 inventors who have changed firms and their complete patents at their first and second firm to construct my sample. They account for 8.7% of the 141,583 total inventors in the data.

If, conditional on similarity, the rate of citation is lower for inventors after they change firms compared to before, then this indicates that the inventor or the new firm is more or less knowingly concealing relevant citations in order to enlarge the scope of the new invention. I find evidence to support this claim. There is a consistent and statistically significant gap in the rate of citation to the inventor's own previous inventions at almost every level of similarity. The difference does grow with similarity up to 0.6, after which the two

⁸This bin represents the 90-99th percentile of similarities in the sample.

measures converge. In the similarity range 0.5-0.6, inventors prior to their move across firms self-cited at a rate of 26.3%, while after the change it becomes 16.4%, a difference of close to 10%. Interestingly, the difference is not statistically significant at the highest level of similarity, largely due to the tapering off of within firm self-citation. One explanation is that there is no risk of patent infringement lawsuits from yourself, and so firms can expand the scope of their new patents by not listing their own highly similar previous inventions.

figure 3.3 shows an example of an inventor who produces two very similar inventions: first, US Patent 7204412 "Family store value card program" was assigned to CompuCredit Intellectual Property holdings, applied for December 27, 2004. US Patent 7325725 "Store value card account transfer system", assigned to Purpose Intellectual Property in February 5, 2005, and yet did *not* cite 7204412.

If inventors cited themselves at their new firms at the same rate as before their move, then the projected number of total citations would be 12112, compared to the actual number of 6422. The total number of "missing" self citations after changing firms represents 89% of the actual number of self-citations.

simDV , binned	-0.2	-0.1	0.0	0.1	0.2	0.3	0.4	0.5	0.6	0.7	8.0
Before Firm Change, ${\cal N}$	671	3898	15868	38162	55625	54663	37899	20148	10389	5871	3553
Before Firm Change, Prop Cites	0.042	0.052	0.059	0.068	0.081	0.104	0.137	0.196	0.263	0.283	0.278
After Firm Change, ${\cal N}$	624	2984	9869	20627	26876	24676	16732	8283	3008	1056	712
After Firm Change, Prop Cites	0.006	0.011	0.011	0.02	0.037	0.06	0.089	0.115	0.164	0.231	0.296
Diff, p -value	0	0	0	0	0	0	0	0	0	0.001	0.322

Table 3.1: Rate of self-citation before and after firm change

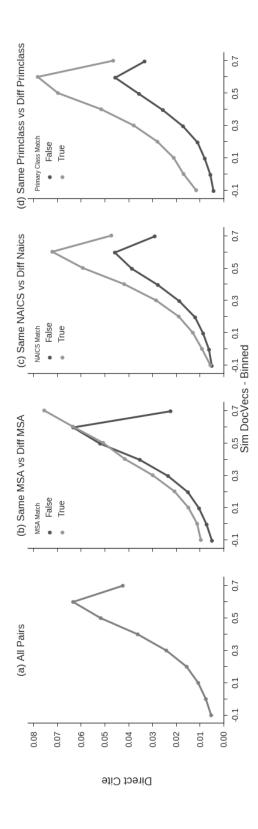


Figure 3.1: Rates of direct citation in the PCPP sample by DocVecs similarity

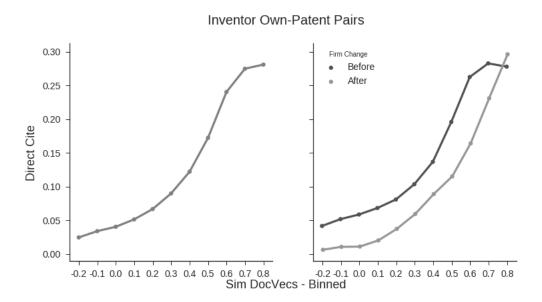


Figure 3.2: Rates of direct citation in the PCPP sample by DocVecs similarity

United States Patent 7,204,412 Foss, Jr. April 17, 2007

Family stored value card program

Abstract

A family stored value card program is provided. One embodiment is a method for implementing a stored value card program. One such method comprises: identifying an existing stored value card account; and enabling a first customer associated with the existing stored value card account to establish a new stored value card account associated with a second customer, the new stored value card account linked to the first stored value card account.

Inventors: Foss, Jr.; Sheldon H. (Suwanee, GA)

Assignee: CompuCredit Intellectual Property Holdings Corp. III (Las Vegas, NV)

Family ID: 39360819 Appl. No.: 11/022,739

Filed: December 27, 2004

Prior Publication Data

United States Patent 7,325,725 Foss, Jr. February 5, 2008

Stored value card account transfer system

Abstract

Systems, methods, computer programs, merchant terminals, etc. for transferring finds between stored value card accounts are provided. One embodiment comprises a method for loading a stored value card. One such method comprises: identifying a first stored value card account associated with a first customer; receiving a selection from the first customer of a second stored value card account associated with a second customer and a load amount for transferring to the second stored value card account; and initiating a funds transfer of the load amount from the first stored value card account to the second stored value card account.

Inventors: Foss, Jr.; Sheldon H. (Suwanee, GA)

Assignee: Purpose Intellectual Property Management II, Inc. (Las Vegas, NV)

Family ID: 39304185 Appl. No.: 11/050,301

Filed: February 3, 2005

Figure 3.3: Example of an inventor moving firms and not self-citing. US Patent 7204412 was not cited by US Patent 7325725.

4. Measuring Local Knowledge Spillovers

4.1. Benchmark: Extension of JTH (1993)

I replicate and extend the work of JTH in order to have a baseline to compare the magnitude of localization effects. JTH sampled patents in their control (target) group in the following manner: from the years 1975 to 1980, they select a random sample of Top Corporate (top 200 by R&D total expenditure measured by Compustat) and Other Corporate patents, and all patents granted to Universities. Their sample size is 950 for 1975 and 1450 for 1980 respectively. Then, for each "target" patent in the sample find a control patent that is as close as possible to the target in *grant date* in the *same patent primary class*. JTH claim that this accounts for the "existing distribution of technological activity," and thus if citations are more likely to be from the same geographical area as the target patent over the control, then it is evidence for the existence of localized knowledge spillovers. Here, a citation is a patent that cites the target.

In my method, I use a larger sample of target patents granted 1976-2005,⁹ and limit forward citations to be within 10 years of the target patent's grant date. Self-citations of patents granted to the same assignee are similarly excluded. The only point of departure is that due to lack of data, I do not use separate categories of patents by assignee "type", and pool all patents by grant year. Compared to the original JTH results (table III, p. 590), my results are fairly well aligned with their 1980 cohort figures for top corporate patents. ¹⁰

I find that the measure of localization using citations based spillover measures is substantial and *rising* in size over time, concurring with Sonn and Storper (2008). The difference in the percentage of citations matching the target's MSA grows from 5.32% in 1975-85 to 6.46% two decades later. Relatively speaking, the effect is substantial: local patents are twice as likely to cite other local patents as non-local patents of the same primary class. The increase in both the target and the control's citations matching the target's MSA may indicate growing concentration in relevant inventions across locations.

To isolate the effect of localization, the above exercise can be represented as a regression model:

$$pct \ cites \ in \ MSA_T = \beta_0 + \beta_1 I(MSA_i = MSA_T) + Year \ FE + \epsilon$$
(4.1)

Primcary class fixed effects are also added:

 $^{^92005}$ is the last year that 10 year forward citations are available for

¹⁰8.8 for target match and 3.6 for control match; compared to 9.09 and 3.77 for my results. Slight discrepancies may arise due to sample selection and slight differences in removing self-citations.

Grant Year	Pct Targ Cites in MSA_T	$ \mbox{ Pct Control Cites in } MSA_T $	Diff	t-stat	p-value	N obs
1975-85	9.09	3.77	5.32	33.01	0.0	34489
1985-95	9.71	3.48	6.24	55.25	0.0	59102
1995-05	10.98	4.52	6.46	71.97	0.0	99248

Table 4.1: JTH Extension Results

$$pct cites in MSA_T = \beta_0 + \beta_1 I(MSA_i = MSA_T) + Year FE + \epsilon$$
(4.2)

Where $i \in \{T = target, C = control\}$. Here, $I(MSA_T = MSA_T) = 1$, $I(MSA_C = MSA_T) = 0$. Then, as in 1.1, the estimated measure of localization is $\hat{\beta}_1$. In this case, $\hat{\beta}_1$ represents the (approximate) increase in the percentage of citations in a particular MSA for a patent in the same MSA vs from different MSAs.

4.2. Changing the spillover measure to similarity

With similarities, we do not necessarily require a control patent as a point of comparison. The use of the control patent has been scrutinized previously, notably by Thompson and Fox-Kean (2005), who argue that technological differences cannot be fully accounted for by selecting on primary class. In devising an analogous similarity measure of spillovers using the same sample above, I consider what approach is possible under similarities that was not using citations, that might better approximate local spillovers. Instead of using a control patent as baseline, I instead take the cross patent similarity of a target patent with citations from its own MSA, to citations in different MSAs. This approach has a straightforward interpretation: localization is present if a patent is more similar to its forward citations from the same MSA compared to those from different MSAs. This would mean that of the subsequent patents directly influenced by the target, on average, patents from the same location as the target share more in common.

I find that target patents *are* more similar to citations matching its own MSA, compared to citations from other MSAs. However, the relative magnitude of the effect is much smaller compared to the JTH citations measure. DocVecs measures find that local citations are about 15% more similar; for LDAVecs, same MSA citations are about 10% more similar than citations from different MSAs.

Grant Year	$\overline{sim_{DV}(T,j jinMSA_T)}$	$\overline{sim_{DV}(T,j j\ not\ in\ MSA_T)}$	Diff	t-stat	$p ext{-}value$
1975-85	0.35	0.29	0.05	25.53	0.0
1985-95	0.33	0.29	0.05	33.05	0.0
1995-05	0.32	0.28	0.04	42.39	0.0
2005-15	0.31	0.27	0.04	26.92	0.0
Grant Year	$\overline{sim_{LDA}(T,j jinMSA_T)}$	$\overline{sim_{LDA}(T,j jnotinMSA_T)}$	Diff	t-stat	p-value
1975-85	0.58	0.53	0.05	17.81	0.0
1985-95	0.57	0.51	0.06	27.66	0.0
1995-05	0.54	0.49	0.05	33.25	0.0
2005-15	0.53	0.48	0.05	20.79	0.0

Table 4.2: JTH Replication Results with Similarity Measures.

Here, j is a patent that cites target T. $\overline{sim(T,j)}$ is the average of the pairwise similarities between the target and each of the forward citations j that are either located in the same MSA as T or not. In regression form, I estimate:

$$\overline{sim(T,j)} = \beta_0 + \beta_1 I(MSA_j = MSA_T) + Year FE + \epsilon$$
(4.3)

$$\overline{sim(T,j)} = \beta_0 + \beta_1 I(MSA_j = MSA_T) + Year\,FE + Primclass\,FE + \epsilon \tag{4.4}$$

 $\hat{\beta}_1$ measures the proportional increase in the average similarity of a patent to citations in the same MSA compared to the similarity to citations in different MSAs, subject to controls.

4.3. Using random patent-pair similarity to measure spillovers and localization

As outlined in section 3, citations may omit many possible transmissions of knowledge. I change the measure of spillovers to similarity across random pairs of patents within a technology field, that is either (i) within primary class or (ii) within a NAICS field. ¹¹Including random pairs captures potential shared

¹¹The caveat is that the interpretation of the localization measure is different to those using primary class patents, as in this case it measures the effect of being in the same location for two patents within the same *industry*, which is a much wider definition of technology. The mean cross-patent similarity is much lower in this sample, which leads to larger estimates for

knowledge for any pair of patents and not only those linked by citation relationships, which represent only a small fraction of possible patent pairs. The hypothesis becomes: knowledge spillovers are localized if patent pairs within a field are more similar if they are from the same MSA compared to different MSAs. Focusing on patent pairs also allows me to bypass issues related to composition with more aggregated measures, and make these results more directly comparable with the JTH-based exercises above. The use of both within-NAICS and within-primary class samples allows me to compare spillover effects at broader and narrower technology levels. If localization measure is different for NAICS and primary class, then this indicates that there are differences in the dynamics of knowledge diffusion at the industry level and at more specialized or granular definitions of technology. In addition, using the NAICS sample which is comprised of numerous primary classes allows me capture the possibility of knowledge spillovers occurring across narrower subfields of technology.

I measure localization in two ways. In the first case, localized knowledge spillovers can be said to be *generally* present if patent pairs *within a field* are more similar. This definition esentially equates localized knowledge spillovers with industry level clustering at a location: if particular sub-fields of an industry collocate, then localization will be found significant. There has been much discussion in the existing literature as to whether or not this is an adequate control for technological proximity, even within JTH, who state: "... if a large fraction of citations to Stanford patents comes from the Silicon valley, we would like to attribute this to localization of spillovers. A slightly different interpretation is that a lot of Stanford patents relate to semiconductors, and a disproportionate fraction of the people interested in semiconductors happen to be in the Silicon valley, suggesting that we would observe localization of citations even if proximity offers no advantage in receiving spillovers." I accommodate this possibility in the second case: to better control for the existing technological proximity I also use cross-field similarity and cross-location-field similarity. Knowledge overlap may occur just through being in the same or similar technological fields; that the inputs to creating innovation in class *396: Photography* might overlap significantly with class *398: Optical communications.* If these two fields are collocated (i.e. innovation in both classes occur in the same location), then we may over-attribute the effect of technological affinity to localization.

On the other hand, a well-known problem in the literature is that identification may be confounded as firms from similar technology fields also collocate in order to take advantage of potential spillovers, alongside other agglomeration benefits. Thus, controlling for the similarity across technology fields may be excessive. However, if we use the technology similarity control as a proxy for these other agglomeration effects, then

coefficients on the log transform, even if the absolute magnitude of the change is roughly constant.

any remaining knowledge localization effects is more reliably attributable to knowledge spillovers. This strict view may give us some sense of the lower bound for the size of localization.

I control for technological proximity using field similarity only within the NAICS sample, as subfield controls are not available for primary classes. Thompson and Fox-Kean (2005) have previously used primary sub-classes, but I find these measures to be extremely noisy: there are over 150,000 subclasses in the USPC system for approximately 2.3 million US patents, which on average implies just 15 patents per subclass.

Since each NAICS field encompasses only a number of primary classes, the number of outcomes for similarity across primary class may be limited. To increase variability, I also use MSA-specific field vectors as described in equation (2.3). This treats each field at each MSA as a separate subfield. The trade off, however, is that this measure can be much noisier, as many MSAs may only have a handful of prior patents in some patent classes. These measures should also be a more "precise" approximation of the underlying patents, which further limits the remaining knowledge spillover to be explained by pure location effects. The expectation is that localization will be lowest when MSA-fields are controlled for.

For the sampling procedure, ¹³ I sample a set of target patents, and pair these patents with both patents from the same field and MSA, and patents just within the same field. This is to ensure a sizable number of patent pairs from the same MSA across a range of technological fields. Patent pairs are granted within 5 years of each other that are assigned to different firms. While some patent pairs may have the same target patent, the number of appearances made by multiples of the same patent is extremely small relative to the entire sample, thus curtailing the presence autocorrelation. ¹⁴

4.3.1. Regression models for general localized knowledge spillovers

For general controls, I add year fixed effects and technology field fixed effects. The complete sample size for all years are approximately 1.5 million pairs for each sample. To allow for the effects to change over time, I group each sample into 10 year cross sections.

For both each measure, I begin by estimating the regression model without technology controls, where i, j are patent pairs within the same technology field:

$$sim(i,j) = \beta_0 + \beta_1 I(MSA_i = MSA_j) + Year FE + \epsilon$$
 (4.5)

¹²I remove the MSA-fields with less than 10 patents

¹³See B.1 for full outline

 $^{^{14}}$ Heteroskedastic-robust standard errors are used in regression estimates

Then I add technology field fixed effects:

$$sim(i,j) = \beta_0 + \beta_1 I(MSA_i = MSA_j) + Year FE + Field FE + \epsilon$$
 (4.6)

The first two equations are directly comparable to JTH regressions equation (4.1) and equation (4.3). The results from these regressions are reported in table D.2.

4.3.2. Regression models for strict localized knowledge spillovers

For the within NAICS sample, ¹⁵ pre-existing similarity across primary classes can be accounted for:

$$sim(i,j) = \beta_0 + \beta_1 I(MSA_i = MSA_j) + \beta_2 sim(pc_i, pc_j) + YearFE + PrimclassFE + \epsilon$$
 (4.7)

If patent i was granted in 2007 and had primary class 398: Optical communications, the vector pc_i would represent the median of all patents with primary class 398 granted between 2001-2006.

I also allow for the localization effect to affect the slope coefficient β_3 , which would imply that the similarity between patents in the same location *grows more* with the similarity in their primary classes:

$$sim(i,j) = \beta_0 + \beta_1 I(MSA_i = MSA_j) + \beta_2 sim(pc_i, pc_j)$$

$$+ \beta_3 I(MSA_i = MSA_j) * sim(pc_i, pc_j) + Primclass FE$$

$$+ Year FE + \epsilon$$

$$(4.8)$$

MSA-primary class subfields may also be used:

$$sim(i,j) = \beta_0 + \beta_1 I(MSA_i = MSA_j) + \beta_2 sim(pc_{i,MSA_i}, pc_{j,MSA_j})$$

$$+ Year FE + Primclass FE + \epsilon$$

$$(4.9)$$

These regressions can not be applied to the within-primary class sample, as similarity across primary class would be degenerate. Similarity across MSA-primary class pairs is also degenerate when $I(MSA_i = MSA_j) = True$, so it is not possible to separately identify β_1 .

$$sim(i,j) = \beta_0 + \beta_1 I(MSA_i = MSA_j) + \beta_2 sim(pc_i, pc_j)$$

$$+ \beta_3 I(MSA_i = MSA_j) * sim(pc_{i,MSA_i}, pc_{j,MSA_j}) + Primclass FE$$

$$+ Year FE + \epsilon$$

$$(4.10)$$

If patent i was granted in Los Angeles, pc_{i,MSA_i} represents the median of all patents granted in primary class 398 in the city of Los Angeles, from 2001-2006. The interpretation here would be that if $\hat{\beta}_1, \hat{\beta}_2$ or $\hat{\beta}_3$ are positive and significant, then innovations from the same location share more in common compared to other patent pairs from technology fields that are just as similar. For example, suppose $pc_i = 398$ and $MSA_i = Los Angeles$; $pc_j = 396$ and $MSA_j = Austin$; $pc_k = 396$ and $MSA_k = Los Angeles$. If the similarity of past patents from primary class 398 in Los Angeles to primary class 396 from both Austin and Los Angeles, and yet the patent pairs i, k from Los Angeles are more similar on average to the i, j Los Angeles-Austin patent pairs, then localization is significant.

4.4. Summary Statistics

A summary of the dataset from each of the above samples can be found in table D.1. Across all samples, there is a positive difference between local patent pairs $(MSA\,Match=T)$ and non-local pairs $(MSA\,Match=F)$. DocVecs similarity is on average smaller than LDAVecs, but that is largely due to the fact that the range of its values is wider ([-1,1] compared to [0,1]). The similarity for both measures is on average approximately 50% higher for primary class pairs over NAICS pairs, which aligns with expectations that patents in more finely defined technology fields are more similar to each other. However, variance is also slightly higher for primary class, which is less reassuring as it indicates either some noisiness in the similarity measure or primary classification, neither of which is desirable. Citation similarity is on average highest of all, which also matches expectations as citations should indicate necessary prior art for the invention. The fact that the variation for local citations is much higher than non-local citations (even compared to the primary class sample) also matches the discussion in section 3.1, which finds that less relevant local patents are more likely to be cited.

4.5. Results: Estimating Localization From Regression

4.5.1. General localized knowledge spillovers

To directly compare the size of localization from each method, I normalize all measures of spillovers. Then the estimate of $\hat{\beta}_1$, which represents the standard deviation increase in knowledge spillovers when patents are local. The same results with raw untransformed data is reported in table D.2, alongside results for LDAVecs (table D.3,table D.4). I will focus on the results from DocVecs which I consider a better approximation of document similarity, as discussed in section $\ref{localization}$; LDAVecs serve as a validation exercise for the results. In the vast majority of cases, the sign and significance of the the coefficient estimates align, while some magnitudes may differ.

The main finding is that the citations-based measure of the JTH extension exercise finds much larger relative effects for localization that for all other measures. Being in the same location increases the percentage of citations from that location by 0.24 standard deviations in 1975-85; this grows to 0.24 in 2005-2015. ¹⁶ Including primary class fixed effects does not affect the estimated size of localization.

By comparing same MSA citations to different MSA citations, a very different picture emerges. The normalized measure of average similarity does not find significantly higher similarity for in-MSA citations (although the difference is positive and significant in the raw data, table D.2) for the years 1985-2015. The contrast between these results and the results from using just citation rates demonstrates how different the perspective from using similarity can be, even when using the same base data: the two samples share the same target patents and citations.

The size of the localization effect using the NAICS and Primclass samples are significant and positive, although modest. According to these results, being in the same location increases similarity by between 0.03-0.09 standard deviations. In terms of time trends, both samples find highest localization levels in 1995-2005, with a slight decline in the subsequent decade. Overall, localization appears to be fairly stable 1985-2015. All measures agree that the lowest rates of localization occur in the first decade of observation, 1975-1985.

In general, there appears to be higher localization at the primary class level compared to the NAICS level, meaning that patents are more similar to other local patents in narrower fields of technology. This indicates that local knowledge sharing may happen more in specialized areas of innovation, compared to knowledge sharing at the industry level.

¹⁶Some truncation bias will be present in this sample as citations data only extend to 2015

4.5.2. Strict localized knowledge spillovers

I find that including prior similarity across primary classes as controls in the within NAICS sample reduces the estimate for localization further, so that local patent pairs are about 0.025-0.045 standard deviations higher than non-local pairs $(I(MSA\,Match)=False)$. For the same time range but without the similarity controls, ¹⁷ the localization estimate is 0.05-0.06. The time trend indicates that localization is diminishing over the period 1985-2015. The interaction term is also found to be slightly positive and significant for 1985-2015, stable at around 0.026; this means that local patent similarity grows at a slightly higher rate with primary class similarity. figure 4.1 depicts the conditional means plot. The raw data (table D.5) differs slightly in that the coefficient on the intercept dummy (i.e. $\hat{\beta}_1$ in equation (4.7)) is slightly negative and significant, versus positive and significant in the normalized regressions.

Interestingly, including MSA-specific primary class controls estimates localization to be significant and slightly negative. Local patent pairs are found to be between 0.017-0.023 standard deviations less similar than non-local patent pairs. The interaction term is found to be insignificant 1985-2005, and slightly positive and significant in 2005-2015. One thing that contributes to the negative estimate of the dummy intercept term is that $sim(pc_i,pc_j)$ is not highly correlated with I(MSAMatch) at 0.04; while the pairwise correlation with $sim(pc_{i,MSA_i},pc_{j,MSA_j})$ is 0.19.¹⁸ In other words, patent pairs from similar MSA-technology subfields are much more likely to be collocated than those from similar primary classes. Since the average difference between the local and non-local samples are already low, this slight collinearity may reduce the estimated effect of I(MSAMatch) even further. Another view could be that the collocation of patents from similar MSA subfields already indicates some presence of spillovers; while this certainly indicates the presence of clustering, whether or not clustering is equatable to local spillovers is open to interpretation.

The conditional mean plot (figure 4.2) also sheds light on this effect. The average similarity of non-local patent pairs is slightly higher than local pairs at *higher* levels of MSA-subfield similarity. What is interesting is that local similarity does not increase as subfield similarity rises from 2 s.d. above the mean to 2.5; while non-local similarity does substantially (the caveat being there are far fewer non-local patent pairs in the 2.5 bin). This may indicate the presence of *local differentiation* in technology space. One aspect of local knowledge spillovers may be that knowing more about neighbouring rivals' inventions may push inventors to distance themselves from one another. That is, inventors want their innovations to be novel from that

¹⁷1975-1985 sample drops out due to lack of data on past primary class patents.

¹⁸The distributions of these two measures for local and non-local patent pairs are in figure D.1,figure D.2.

of their peers, as patents are more valuable when they have a broader scope. These results show that learning from local rivals may not necessarily lead to greater technological affinity.

For patent pairs with subfield similarity above 2 s.d., approximately 19% are Pharmaceutical pairs and a further 14% are Other Chemical Product pairs. In the general sample, they comprise 3.3% and 4.9% respectively. In both industries, particularly pharmaceuticals, the patent to product progression is much more straight forward compared to most other industries. As patents in these industries behave more like products, the consideration of product market differentiation may induce greater distancing in technology space by local firms.

While the sign of the results are different for MSA-specific primary class controls, in terms of absolute magnitude they do not differ substantially. The explanatory power of the primary class similarity measure is also slightly greater, as is its estimated effect on patent pair similarity. One standard deviation increase in $sim(pc_i, pc_j)$ increases sim(i, j) by approximately 0.24-0.26 standard deviations; while for $sim(pc_{i,MSA_i}, pc_{j,MSA_j})$ the increase is between 0.17-0.19. Thus, while primary class similarity appear to be a slightly better fit for the data, the exercise using MSA-primary class similarity reveals potentially deeper dynamics of the knowledge spillovers process.

It has been documented by Moser (2011); Arora (1997) that industries such as Chemicals rely more heavily on secrecy to preserve intellectual property which leads to higher rates of localization. On the other hand, industries dominated by software patents which are known to have more diffuse knowledge networks, thus lowering the localization effect. I also drop Machinery pairs as they also constitute a large proportion of the total sample. I find that dropping each of these industries from the sample do not affect the estimation results in table 4.3 or table 4.4. Using assignee level fixed effects such a firm size also have no effect. Using data at the patent pair level and including technology fixed effects has made the results fairly robust.

The overall findings on the presence and size of localized knoweldge spillovers is mixed using similarity measures. While citations finds large and significantly positive localization effects, the findings with similarity is comparatively much more muted. One drawback to the regression exercise on similarity across random pairs is that the innovative knowledge being generated in this process is continuous and may have originated prior to the sample period. If localization effects are time dependent, i.e. if knowledge spillovers are more localized when new innovative knowledge is first generated, then these regressions may not be able to capture these effects. In the next section, I explore a number of case studies where there is an exogenous introduction of new knowledge to the patent pool.

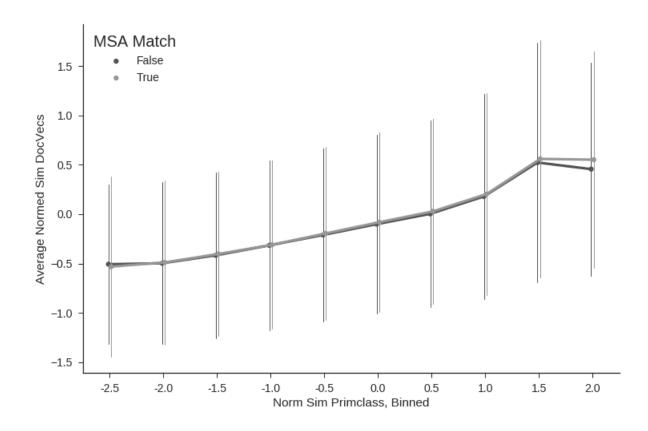


Figure 4.1: Conditional means of DocVec similarity by primary class similarity.

				.975-85				
Sample	JTH			ite Sim		AICS		nclass
Spillover	$pct\ cites\ in\ MSA_T$		$\overline{sim_{DV}(T,j)}$			$p_V(i,j)$		V(i,j)
	(1)	(2)	(3)	(4)	(5)	(6)	(7)	(8)
I(MSAMatch)	0.2448***	0.2416***	0.0469***	0.0444***	0.0323***	0.0185***	0.0527***	0.0486**
	(0.0074)	(0.0073)	(0.0145)	(0.0145)	(0.0053)	(0.0054)	(0.0064)	(0.0066)
N	58647	58647	38541	38541	192841	192841	170882	170882
Adjusted \mathbb{R}^2	0.02	0.03	0.00	0.03	0.00	0.07	0.00	0.07
Year FE	True	True	True	True	True	True	True	True
PC FE	False	True	False	True	False	True	False	True
			1	985-95				
Sample	JTH	l Cite	JTH C	ite Sim	NA	ICS	Prim	class
Spillover	$pct\ cites$	$in MSA_T$	$\overline{sim_{DV}}$	$\overline{\gamma(T,j)}$	sim_{DV}	$\gamma(i,j)$	sim_D	V(i,j)
	(1)	(2)	(3)	(4)	(5)	(6)	(7)	(8)
I(MSAMatch)	0.2881***	0.2846***	0.0154	0.0158	0.0605***	0.0521***	0.0798***	0.0781**
	(0.0052)	(0.0051)	(0.0097)	(0.0097)	(0.0043)	(0.0044)	(0.0050)	(0.0052)
N	107358	107358	69612	69612	281222	281222	252174	252174
Adjusted \mathbb{R}^2	0.03	0.05	0.00	0.03	0.00	0.07	0.00	0.07
Year FE	True	True	True	True	True	True	True	True
PC FE	False	True	False	True	False	True	False	True
			1	.995-05				
Sample	JTH	l Cite	JTH C	ite Sim	NAI	ICS	Prim	class
Spillover	$pct\ cites\ in\ MSA_T$		$\overline{sim_{DV}(T,j)}$		$sim_{DV}(i,j)$		$sim_{DV}(i,j)$	
	(1)	(2)	(3)	(4)	(5)	(6)	(7)	(8)
I(MSAMatch)	0.2983***	0.2966***	-0.0047	0.0064	0.0610***	0.0576***	0.0787***	0.0836**
	(0.0041)	(0.0041)	(0.0067)	(0.0066)	(0.0034)	(0.0035)	(0.0038)	(0.0039)
N	185154	185154	122217	122217	437685	437685	401623	401623
Adjusted \mathbb{R}^2	0.03	0.05	0.00	0.04	0.00	0.08	0.00	0.08
Year FE	True	True	True	True	True	True	True	True
PC FE	False	True	False	True	False	True	False	True
				005-15				
Sample	JTH	l Cite		ite Sim	NAI	ICS	Primclass	
Spillover	$pct\ cites$	$in MSA_T$	$\frac{\overline{sim_{DV}(T,j)}}{}$		$sim_{DV}(i,j)$		sim_D	V(i,j)
	(1)	(2)	(3)	(4)	(5)	(6)	(7)	(8)
I(MSAMatch)	0.3417***	0.3365***	0.0157	0.0178*	0.0571***	0.0562***	0.0573***	0.0600**
. '/	(0.0054)	(0.0054)	(0.0108)	(0.0108)	(0.0030)	(0.0031)	(0.0032)	(0.0033)
	154619	154619	52710	52710	569252	569252	529686	529686
N								
N Adjusted \mathbb{R}^2	0.02	0.05	0.00	0.04	0.00	0.06	0.00	0.07
N Adjusted R^2 Year FE	0.02 True	0.05 True	0.00 True	0.04 True	0.00 True	0.06 True	0.00 True	0.07 True

Table 4.3: Regression results for general spillovers with normed data for DocVec similarity.

	1985-95			
	(1)	(2)	(3)	(4)
I(MSAMatch)	0.0399***	-0.0177***	0.0434***	-0.0169***
	(0.0042)	(0.0047)	(0.0043)	(0.0049)
$sim_{DV}(pc_i,pc_j)$	0.2475***		0.2408***	
	(0.0024)		(0.0026)	
$sim_{DV}(pc_{i,MSA_i}, pc_{j,MSA_j})$		0.1719***		0.1698***
		(0.0026)		(0.0033)
$I_{MSA} * sim_{DV}(pc_i, pc_j)$			0.0254***	
			(0.0041)	
$I_{MSA}*sim_{DV}(pc_{i,MSA_i},pc_{j,MSA_j})$				0.0051
				(0.0046)
N	281018	227029	281018	227029
Adjusted R^2	0.11	0.09	0.11	0.09
Year FE	True	True _	True	True
PC FE	True	True	True	True
	1995-05			
	(1)	(2)	(3)	(4)
I(MSAMatch)	0.0360***	-0.0226***	0.0371***	-0.0228***
	(0.0033)	(0.0036)	(0.0033)	(0.0036)
$sim_{DV}(pc_i,pc_j)$	0.2448***		0.2377***	
	(0.0019)		(0.0021)	
$sim_{DV}(pc_{i,MSA_i},pc_{j,MSA_j})$		0.1919***		0.1905***
		(0.0020)		(0.0024)
$I_{MSA} * sim_{DV}(pc_i, pc_j)$			0.0261***	
			(0.0033)	
$I_{MSA} * sim_{DV}(pc_{i,MSA_i}, pc_{j,MSA_j})$				0.0035
				(0.0035)
N	437485	382972	437485	382972
Adjusted R ²	0.12	0.11	0.12	0.11
Year FE PC FE	True	True	True True	True
FC FE	True	True	True	True
	2005-15			
	(1)	(2)	(3)	(4)
I(MSAMatch)	0.0327***	-0.0175***	0.0266***	-0.0228***
	(0.0030)	(0.0032)	(0.0030)	(0.0033)
$sim_{DV}(pc_i, pc_j)$	0.2553***		0.2481***	
	(0.0019)		(0.0021)	
$sim_{DV}(pc_{i,MSA_i}, pc_{j,MSA_j})$		0.1916***		0.1870***
T		(0.0018)	0.0000	(0.0021)
$I_{MSA} * sim_{DV}(pc_i, pc_j)$			0.0263***	
In a state of many and many and and a second			(0.0034)	0 0120***
$I_{MSA} * sim_{DV}(pc_{i,MSA_i}, pc_{j,MSA_j})$				0.0132***
N	569100	516531	569100	(0.0032) 516531
Adjusted R^2	0.09	0.08	0.09	0.08
Year FE	True	True	True	True
PC FE	True	True	True	True
	TTUE	HUC	TTUE	iiuc

Table 4.4: Regression results for strict local spillovers with normed data for LDAVec similarity.

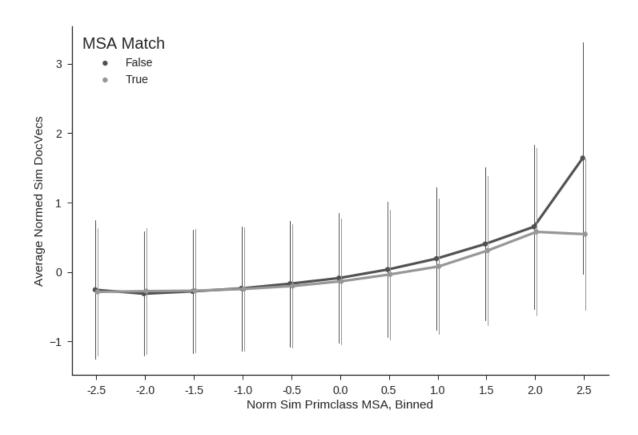


Figure 4.2: Conditional means of DocVec similarity by MSA-primary class similarity.

5. Exogenous new knowledge and local spillovers

A shock of new patents may arrive due to (i) legislative changes (ii) court decisions which alter the scope of knowledge that may be patentable. The main example of legislative change used previously in the literature (Mowery et al. (2001); Henderson et al. (1998)) is the Bayh-Dole Act of 1980, which granted universities the right to retain the intellectual property rights to inventions made using federal funding. While Mowery et al. (2001) challenges the notion that the act was significant in promoting patenting growth at universities, the pool of university patents did enlarge post 1980. (TODO: graph of number of university periods for time period) Another example of government initiatives affecting the stock of innovative knowledge is the launch of the National Nanotechnology Initiative in 2000 by President Clinton. Since that time, cumulative public funding for nanotechnology has totaled over \$12 billion, placing the NNI second only to NASA in terms of government investment in science and technology (Roco (2011)). While the growth in nanotechnology patents may not only be attributable to greater funding, post-2000 its expansion has been considerable.

In the courts, a series of cases in the mid 1990s, most notably In re Lowry (1994) and In re Aleppat (1994), altered the eligibility criteria of software patents (Hall and MacGarvie (2010)). While previously algorithmic software was considered "mathematical formula" and not a patentable subject matter, these decisions abandoned the previous tests and lead to a drastic rise in software patenting (TODO: graph of software patents during this time period).

In each case, I examine a time series comparing the size of localization effects for "treatment" patents (such as patents assigned to universities) to "control" patents from the same industry as the treatment and granted in the same year. The industry level was chosen over primary classes because some treatment patents overwhelmingly dominate the primary class they are in. The idea is to examine if rates of localization differ significantly for the treatment patents introduced in this time period compared to other patents within the same industry but in differing sub-fields. For each patent iin both samples, the size of localization is equal to the difference in the average similarity of i to local and non-local patents j, where j was applied for within 5 years of i:

$$localization_i = \overline{sim(i, j|MSA_i = MSA_j)} - \overline{sim(i, j|MSA_i \neq MSA_j)}$$
 (5.1)

To construct the time series, I then take the average of $localization_i$ by each sample group over each application year.

The exercise is not intended to provide definitive evidence on causality, but rather to see what patterns emerge in local patent similarity following the introduction of a quasi-"exogenous" shock of patents. Note that strict exogeneity cannot be guaranteed, as it is not possible to ascertain the exact reason that caused the generation of patents - that is, a patent application will not state if the patent was generated "because" of any legislation or court case. We may still formulate some hypotheses about how knowledge spillovers may diffuse locally following the shock: there should be an immediate dip in localization within the treatment sample as novel patents arrive, followed by a rise above trend in local similarity as it diffuses more locally, before steadily decreasing to a stable lower level. In the control group of other within-industry patents not affected by the shock, there should be no such effect or very slight effects.

University Patents

I take a sample of all patents assigned to universities that were applied for in 1975-1990 as the treatment, ¹⁹ and a sample of non-university patents from the same industries as the control. I find that around the time of Bayh-Dole, there is a significant decline in the size of localization for the university sample: from 0.06 in 1978 to -0.015 in 1979. The slight deviation in timing could be due to some anticipation of the bill, as most patents applied for in 1979 are not granted until 1980 or 1981. There is no such decline for the control group, and the difference in localization effect is significant over this period. This dip in localization aligns with our expectations, however there is no accompanying rise above trend in subsequent localization; it merely reverts to the long term trend in 1981.

The lack of advantages for local innovation could be explained by the fact that knowledge flows from university patents tend to be less localized (Henderson et al. (1998)) that privately generated innovation, since universities typically have their own knowledge networks that are somewhat separate from local innovators. This analysis differs from Belenzon and Schankerman (2013) who do find that knowledge spillovers (as measured by citations) are highly localized for university patents.

Nanotechnology Patents

I take a sample of nanotechnology patents for the years 1990-2005 These are patents that contain the phrase "nano" in the abstract. Since the vast majority of nanotechnology patents are part of the Semiconductors industry, I use only Semiconductor treatment and control patents. I find that there is a statistically significant dip (see table E.2) in localization in the year 2000, when the NNI was announced, followed by a

¹⁹Application is used instead of grant year as it correlates more to when inventions were made.

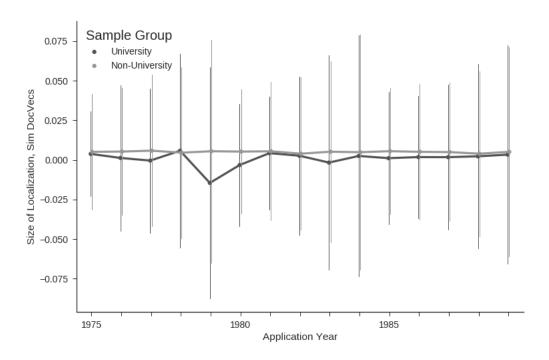


Figure 5.1: Comparison of mean and standard deviation of localization effect for university vs non-university patents within the same industry by application year

slight recovery and a subsequent return to long term trend. The variation in localization measures for the years 1990-1993 are likely caused by the small sample size of nanotechnology patents in these years (only 40-80 patents were applied for in each year). The commercial availability of the atomic force microscope in 1989, allowing firms access to a key production technology for the first time, may have also had an effect. The jump in the localization effect in 1993, although large, is not significantly different from the control at the 5% level.

Software patents

For the years 1990-2005, I take all patents containing "software" in the abstract as treatment and other patents in the Computer and Peripheral Equipment industry (where most software patents are classified) as control. I find no significant differences in the localization effects between software and non-software patents during the time period in which court cases were relaxing patentability rules (1994-1998). In fact the only significant difference is after the Dot-com bubble burst, where localization rates for software patents were reduced compared to other subfields in the industry. However, these dynamics may be driven by other factors, as many firms exited during this time period. This outcome may also be driven by the

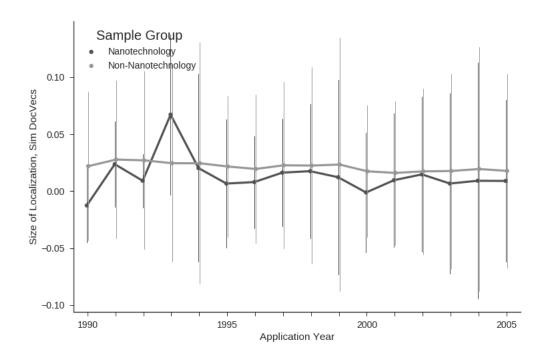


Figure 5.2: Comparison of mean and standard deviation of localization effect for nanotechnology vs non-nanotechnology patents within the Semiconductors industry by application year

software field itself, as the sharing of knowledge within this field in particular is widespread and not inhibited by geography. (TODO: source)

The overall evidence on localization from the perspective of semi-exogenous shocks to the patent stock is limited. While there was some evidence of the introduction of novel patents reducing localization initially, there is scant evidence that localization rates increased subsequent to arrival of new knowledge. That is, localization rates quickly rose back to pre-trend levels, but did not exceed them; this means that knowledge shocks did not flow on to local firms within the same industry at a greater magnitude.

This may point to an ambivalent relationship between knowledge sharing and innovation growth within a particular field. Both similarity and citation measures of knowledge flows look at the affinities between past and present inventions, while innovative growth may rely more on novelty compared to past inventions. In the next setion, I will explore the evidence for a link between local knowledge spillovers and the growth of local innovation

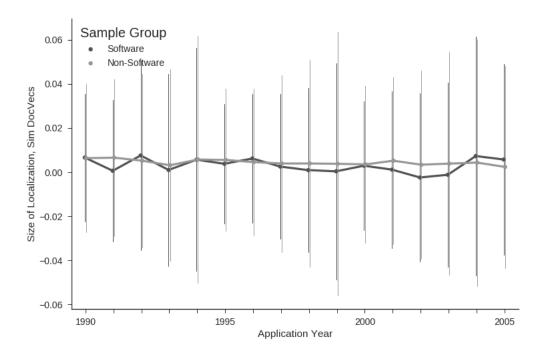


Figure 5.3: Comparison of mean and standard deviation of localization effect for software vs non-software patents within the Computer and Peripheral Equipment industry by application year

6. Do local knowledge spillovers lead to growth in local innovation?

Endogenous growth models such as Romer (1986, 1990) center knowledge diffusion as the mechanism by which technology frontiers expand. Existing theories of agglomeration dating back to Marshall Marshall and Marshall (1920) predict that knowledge spillovers lead to greater agglomeration returns, which produces growth in a particular industry at a location. Theories of industry "clustering" also predict that agglomeration externalities should lead to greater innovation (Porter (1998)). The rationale is that innovative firms gravitate to cities in order to take advantage of agglomeration forces such as high levels of knowledge flows, causing innovation to cluster around certain cities. However, there has been little empirical studies on whether or not knowledge diffusion actually drives further innovation.

To test this notion, I first proxy for the location concentration of innovation using the proportion of new patents granted in a primary class pc at an MSA m for each year t:

$$concentration_{pc,m,t} = \frac{|i \in pc, m, t|}{|i \in pc, t|}$$
(6.1)

Where i is a patent granted in t. Then I calculate the percentage change in concentration t-1 to t, which will be the dependent variable. I then construct proxies for local spillovers using both similarity and citation measures at each pc, m.²⁰ The localization proxy using similarities at pc, m is:

$$sim local_{pc,m,t} = mean\{sim(i,j|MSA_i = MSA_j) - sim(i,j|MSA_i \neq MSA_j)\}_{i \in pc,m,t}$$

$$(6.2)$$

Which is analogous to equation (5.1) in the previous section. This is the average of the difference in similarity between local within-primary class pairs and non-local within-primary class pairs, for all patents granted in year tto MSA-technology field m, pc. For citations, the corresponding measure is:

$$cite local_{pc,m,t} = mean\{pct \ cite \ in \ MSA_T, T - pct \ cite \ in \ MSA_T, C\}_{T \in pc,m,t}$$
 (6.3)

Which is the average of the difference in target citations matching the target's MSA to the control's, given the target is granted in year t to MSA-field m, pc.

As a point of comparison, I construct a measure of local-field *novelty*, by comparing the similarity of the location-field vector (from equation (2.3)) $LFV_{m,pc,t}$ to the field vector $FV_{pc,t}$, $sim(LFV_{m,pc,t}, FV_{pc})$.

²⁰Primary class is chosen over industry so that citation localization proxies could be used.

$y = pct chg concentration_{pc,m,t}$	(1)	(2)	(3)	(4)
Intercept	0.2894	0.2895	1.0045	1.0043
	(0.0003)	(0.0007)	(0.037)	(0.037)
$sim local_{pc,m,t-1}$	0.0025			0.0008
	(0.0053)			(0.0101)
$cite local_{pc,m,t-1}$		0.0025		0.0024
		(0.0103)		(0.0052)
$sim(LFV_{m,pc,t}, FV_{pc})$			-0.4276	-0.4276
			(0.0221)	(0.0221)
N	35034	35034	35034	35034
R^2 (Overall)	0.00	0.00	0.0271	0.0271

Table 6.1: Panel OLS Results explaining the percentage change in concentration of innovation at a particular location.

Intuitively, this represents how close a location's innovation is within years t-5,t to overall innovation in that field. Thus, smaller values of this similarity represents more distant and "novel" local innovation.

To test whether local spillovers or local novelty spurs innovation growth, I regress each of the variables lagged on $pct chg concentration_{pc,m,t}$ using a panel OLS model with pc,m entity effects and ttime effects. Error terms are clustered by entity. I find that neither of the local spillover measures are significant in explaining changes in innovation concentration, while local novelty does have a significant effect. An reduction in $sim(LFV_{m,pc,t},FV_{pc})$ by one standard deviation will increase the percentage change in the concentration of innovation in pc at m by 0.43%. While the size of the effect is relatively modest, it demonstrates that local innovation growth is not explained by local spillovers, and that improving the novelty of local innovation does to some extent boost the proportion of a technology field's innovation that is concentrated in a particular city.

 $^{^{21}}$ With the exception of $sim(LFV_{m,pc,t},FV_{pc})$, which already uses patents from previous years.

7. Conclusion

This paper focuses on knowledge spillover dynamics of ideas embodied by innovation. By focusing on patent texts, the evidence for geographic localization is much weaker compared to results found by exclusively using patent citations. These findings reveal a potential difference between the the geographic dynamics of the inputs and influences to the innovative process and its knowledge outputs. This implies that studying the flows of knowledge using citations is not interchangeable with studying flows within knowledge content. This has profound impact for citations based research, which has relied on an assumption of equivalence between the two. I discussed reasons within the patent citations literature of what may be behind the discrepancies, largely due to the strategic manner in which citations are made in relation to the value of patents as intellectual property. However, I expect that this may be attenuated within the academic literature, where there are fewer incentives for strategic citations. More research should focus on when and why there are significant differences in the localization of knowledge inputs to knowledge outputs.

There are also implications for R&D policy: public investment in R&D has been advocated on the premise of the existence of large and significant local returns. These findings complicate the advantages that knowledge spillovers offers, in that they do not appear to benefit local firms and inventors significantly more so. Additionally, there is limited evidence that localization spurs further innovation within a city. If this is the goal, then R&D policy should be directed towards improving possibilities for novel and radical innovation, not necessarily the greater sharing of existing knowledge. Further research should be conducted to investigate the relationship between knowledge spillovers, innovation novelty, and innovation growth.

Appendix

A. Text to Data

A.1. Text cleaning

Each abstract is stemmed to the root word (for example, computer to comput), and stop words (such as "and", "the") are removed. The first step in converting text to data is to represent words and documents in their simplest vector forms. For all algorithms besides Document Vectors, input into the algorithms involve the construction of a document-term matrix from all patents; each row is indexed by the document ID and each column represents a word in the vocabulary. A document row vector represents the count of the number of times the term appears in the document. For the terms, I drop all terms that appear in more than 10% of all patents, and those that appear in fewer than $20.^{22}$ Of the resulting terms, I keep the most common 40,000, in order to maintain a manageable matrix dimensionality. Once all 2,306,041 patents have been transformed into a document-term matrix of dimension 2306041×40000 , I proceed to transforming patents into a smaller dimensional vector representation using the methods described below. This procedure is commonly called the *bag-of-words* representation of text data.

²²Including very common and very infrequent terms may introduce noise and considerable increases in computation times.

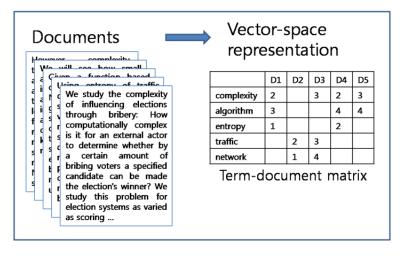


Figure A.1: Example of Document Term Matrix

A.1.1. Paragraph Vectors (Doc2Vec)

One recent advance in NLP which utilises neural networks is Paragraph Vectors, introduced by Le and Mikolov (2014). This is a straightforward extension of the word2vec model of Mikolov et al. (2013b,a). The word2vec model attempts to rectify one of the well-known problems of NLP: the inability of "one-hot" word vectors to account for word similarity. Typically, word vectors are represented as sparse vectors. For example, in a complete vocabulary of ["good", "fair", "fine"], the word good would be represented as the vector [1,0,0], fair as [0,1,0] and fine as [0,0,1]. Clearly, each of these vectors are orthogonal to each other and have a similarity of 0. Instead of using this class of word vectors, word2vec tries to represent words as dense vectors that encode such similarities; a word2vec vector for each of the three words ["good", "fair", "fine"] will have a high similarity.

The way that this is done is through looking at the context of a word. For example, for the sentence "Provides for unattended file transfers", the word "unattended" has the context ["Provides", "for", "file", "transfers"]. We want to represent each of these words as a vector of arbitrary dimension n. One way to account for context is to predict the context words given the target (Skip-gram); while another way is to predict the target word given the context (Continuous Bag-of-Words). Under Skip-gram, the optimization problem is to maximise the probability of any context word given the current center word. So the objective function is given by:

$$J(\theta) = -\frac{1}{V} \sum_{t=1}^{V} \sum_{-m < j < m} \log p(w_{t+j}|w_t)$$
(A.1)

Where θ represents all parameters: input vector ("one-hot") representation of each word, and the output word2vec representation of each word. m represents the length of the context window; for example m=1 gives the context for "unattended" as ["for", "file"]. The objective function is minimized using stochastic gradient descent.

Paragraph Vectors, or Doc2Vec, extends word2vec merely by adding an additional variable, which will be treated as an additional context vector: paragraph ID. For my data, this will be the patent number, which uniquely identifies every abstract document. Thus, including paragraph ID as an additional word for each context generated from that paragraph will also generate a unique vector associated with the paragraph, as well as the word vectors. Intuitively, the paragraph vector will represent what was learned in other context windows belonging to the paragraph, outside of the present context window: that is, it "acts as a memory that remembers what is missing from the current context." (Le and Mikolov (2014))

Such an approach has been shown to be extremely powerful in accurately capturing cross-word and cross-document similarity (papers?), which is why it is the main focus of my analysis. Other vector representations of patents that I use do not specifically optimize to capture such similarity using contexts.

A.1.2. Latent Dirichlet Allocation

Latent Dirichlet Allocation, introduced by Blei et al. (2003), is a method of topic modeling which seeks to uncover the underlying structure of a group of documents (corpus) using just the observed text. It is a probabilistic model based on hierarchical Bayesian analysis. With probabilistic models, treat observations as outcomes of a data generating model and infer the hidden parameters of that model using posterior inference. Define a "topic" as a discrete distribution over a fixed vocabulary. Assume each topic is generated by drawing a distribution over terms in the vocabulary represented by the vector: $\beta_{\mathbf{k}} = (\beta_{k,1}, ..., \beta_{k,V}) \sim Dir(\eta)$. Additionally, asssume that each document d is generated by the following process:

- 1. Draw a vector distribution over topics: $\boldsymbol{\theta}_d = (\theta_{d,1},...,\theta_{d,K}) \sim Dir(\boldsymbol{\alpha})$
- 2. For each word $w_{d,n}$:
 - a) Draw a topic $k_{d,n} \sim Multinomial(\boldsymbol{\theta}_d)$
 - b) Draw a word based on that topic's distribution over the vocabulary $w_{d,n} \sim Multinomial(\boldsymbol{\beta}_{z_d,n})$

Then the posterior of the hidden variables, conditional on the observed words in each document, is given by:

$$p(\beta_{1:K}, \theta_{1:D}, z_{1:D}|w_{1:D}) = \frac{p(\beta_{1:K}, \theta_{1:D}, z_{1:D}, w_{1:D})}{p(w_{1:D})}$$
(A.2)

An inference algorithm is used to approximate the posterior. Thus, from the observed set of V vocabulary terms $w \in 1,...,V$, the hidden topics $k \in 1,...,K$ (a distribution over words in the vocabulary), and each document's distribution over topics $(\theta_{d,1},...,\theta_{d,K})$ are derived.

Example

Probably go through heuristic example with the highlighted text (borrow from any paper)

B. Citations and Patent Vector Similarity

B.1. Sample Summary

C. Summary of Data

D. Regressions

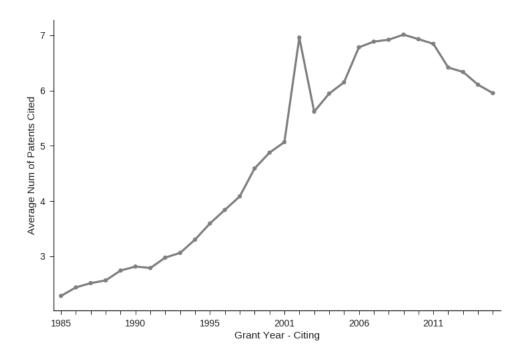


Figure B.1: Averate number of patents cited over time

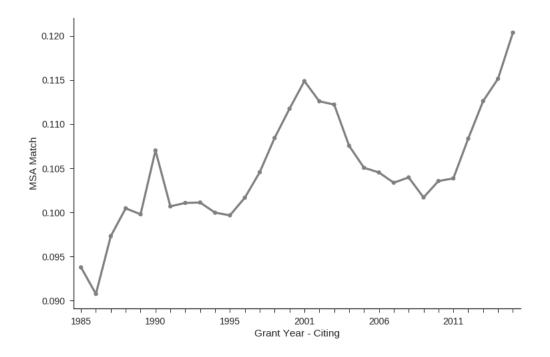


Figure B.2: Proportion of cited patents in the same MSA over time

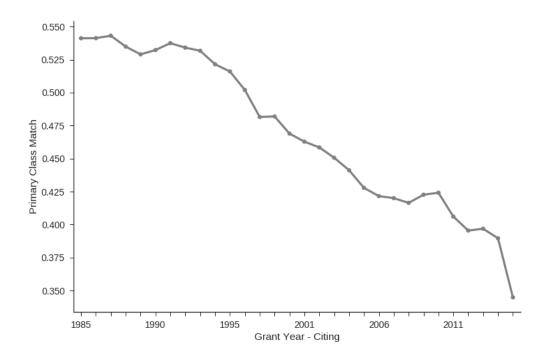


Figure B.3: Proportion of cited patents in the same primary class over time

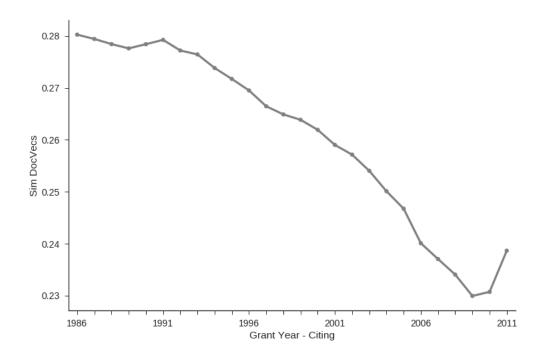


Figure B.4: Average DocVecs similarity to cited patents

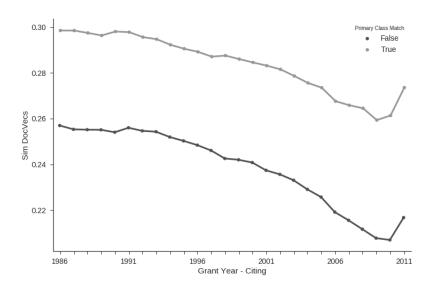


Figure B.5: Average DocVecs similarity to cited patents in the same primary class

sim DV , binned	-0.1	0.0	0.1	0.2	0.3	0.4	0.5	0.6	0.7
All Pairs, \$N\$	51355	205500	498927	685041	562529	293309	102019	27531	18958
All Pairs, Prop Cited	0.005	0.007	0.011	0.016	0.024	0.036	0.052	0.063	0.042
Same MSA, \$N\$	3768	16056	42380	65643	63246	41573	19994	8327	7163
Same MSA, Prop Cited	0.01	0.011	0.015	0.021	0.03	0.041	0.051	0.063	0.075
Diff MSA, \$N\$	47587	189444	456547	619398	499283	251736	82025	19204	11795
Diff MSA, Prop Cited	0.005	0.007	0.01	0.015	0.023	0.035	0.052	0.063	0.022
Same NAICS, \$N\$	21756	92343	239948	354306	313789	175065	64802	18362	13949
Same NAICS, Prop Cited	0.006	0.009	0.013	0.019	0.028	0.042	0.059	0.072	0.047
Diff NAICS, \$N\$	29599	113157	258979	330735	248740	118244	37217	9169	5009
Diff NAICS, Prop Cited	0.005	0.006	0.009	0.012	0.019	0.028	0.039	0.046	0.029
Same Primclass, \$N\$	7035	34445	105794	185777	190332	119502	48211	14968	13148
Same Primclass, Prop Cited	0.012	0.017	0.021	0.028	0.038	0.051	0.07	0.078	0.046
Diff Primclass, \$N\$	44320	171055	393133	499264	372197	173807	53808	12563	5810
Diff Primclass, Prop Cited	0.004	0.006	0.008	0.011	0.017	0.026	0.036	0.046	0.033

Table B.1: Summary table of rates of direct citation in the PCPP sample by DocVecs similarity

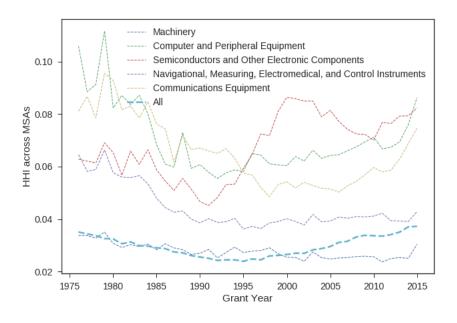


Figure C.1: HHI of concentration across cities for industry innovation

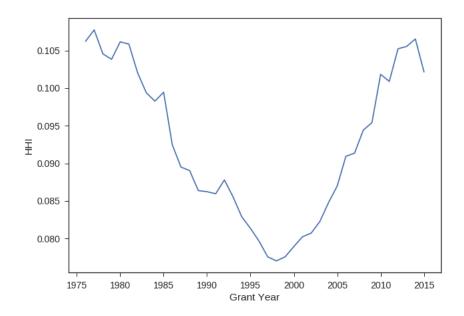


Figure C.2: HHI of concentration across cities for industry innovation

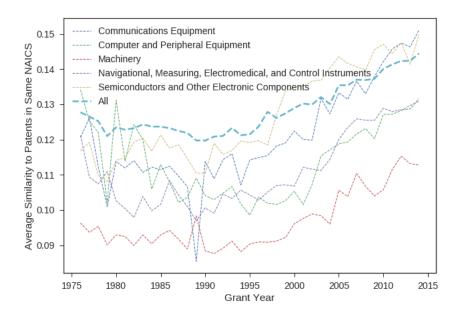


Figure C.3: DocVecs Similarity to other patents within the same industry over time

Sample	Subset	y, KS	N	Mean	Std Dev	Min	25%	50%	75%	Max
JTH Extension	All	$pct\ cites\ in\ MSA_T$	507870	0.082	0.217	0.000	0.000	0.000	0.000	1.000
	MSAMatch = T	$pctcitesinMSA_T$	282079	0.112	0.250	0.000	0.000	0.000	0.042	1.000
	MSAMatch = F	$pctcitesinMSA_T$	225791	0.045	0.159	0.000	0.000	0.000	0.000	1.000
JTH Cite Sim	All	$\overline{sim_{LDA}(T,j)}$	283080	0.510	0.201	0.002	0.369	0.509	0.654	1.000
	MSAMatch = T	$\overline{sim_{LDA}(T,j)}$	57897	0.550	0.222	0.002	0.392	0.555	0.721	1.000
	MSAMatch = F	$\overline{sim_{LDA}(T,j)}$	225183	0.500	0.194	0.002	0.365	0.499	0.638	1.000
JTH Cite Sim	All	$\overline{sim_{DV}(T,j)}$	283080	0.289	0.124	-0.552	0.211	0.285	0.362	0.936
	MSAMatch = T	$\overline{sim_{DV}(T,j)}$	57897	0.323	0.151	-0.552	0.224	0.314	0.409	0.936
	MSAMatch = F	$\overline{sim_{DV}(T,j)}$	225183	0.280	0.114	-0.518	0.209	0.279	0.351	0.890
NAICS	All	$sim_{LDA}(i,j)$	1483214	0.242	0.222	0.001	0.061	0.174	0.368	1.000
	MSAMatch = T	$sim_{LDA}(i,j)$	363370	0.255	0.228	0.001	0.067	0.188	0.389	1.000
	MSAMatch = F	$sim_{LDA}(i,j)$	1119844	0.237	0.220	0.001	0.059	0.169	0.361	1.000
NAICS	All	$sim_{DV}(i,j)$	1481000	0.131	0.135	-0.416	0.039	0.123	0.213	0.679
	MSAMatch = T	$sim_{DV}(i,j)$	362662	0.136	0.136	-0.416	0.043	0.128	0.219	0.679
	MSAMatch = F	$sim_{DV}(i,j)$	1118338	0.129	0.134	-0.416	0.037	0.121	0.211	0.679
Primclass	All	$sim_{LDA}(i,j)$	1355828	0.377	0.245	0.001	0.172	0.347	0.559	1.000
	MSAMatch = T	$sim_{LDA}(i,j)$	285175	0.389	0.249	0.001	0.180	0.360	0.577	1.000
	MSAMatch = F	$sim_{LDA}(i,j)$	1070653	0.374	0.244	0.001	0.170	0.343	0.554	1.000
Primclass	All	$sim_{DV}(i,j)$	1354365	0.188	0.139	-0.371	0.094	0.183	0.275	0.748
	MSAMatch = T	$sim_{DV}(i,j)$	284609	0.196	0.142	-0.367	0.100	0.190	0.284	0.748
	MSAMatch = F	$sim_{DV}(i,j)$	1069756	0.186	0.138	-0.371	0.093	0.181	0.273	0.748

 Table D.1: Summary statistics of knowledge spillover measures.

E. Exogenous new knowledge

Some words at the end

				.975-85				
Sample	JTH	l Cite		ite Sim	NA	ICS	Prim	nclass
Spillover	$pct\ cites$	$inMSA_T$	$\overline{sim_{DV}}$	$\sqrt{(T,j)}$	sim_D	V(i,j)	sim_D	V(i,j)
	(1)	(2)	(3)	(4)	(5)	(6)	(7)	(8)
I(MSAMatch)	0.0530***	0.0523***	0.0543***	0.0540***	0.0025***	0.0044***	0.0067***	0.0073**
	(0.0016)	(0.0016)	(0.0021)	(0.0021)	(0.0007)	(0.0007)	(0.0009)	(0.0009)
N	58647	58647	38541	38541	192841	192841	170882	170882
Adjusted \mathbb{R}^2	0.02	0.03	0.02	0.05	0.00	0.07	0.00	0.07
Year FE	True	True	True	True	True	True	True	True
PC FE	False	True	False	True	False	True	False	True
			1	.985-95				
Sample	JTH	l Cite	JTH C	ite Sim	NA	ICS	Prim	ıclass
Spillover	$pct\ cites$	$in MSA_T$	$\overline{sim_{DV}}$	V(T,j)	sim_D	V(i,j)	sim_D	V(i,j)
	(1)	(2)	(3)	(4)	(5)	(6)	(7)	(8)
I(MSAMatch)	0.0624***	0.0616***	0.0468***	0.0469***	0.0070***	0.0082***	0.0108***	0.0111**
	(0.0011)	(0.0011)	(0.0014)	(0.0014)	(0.0006)	(0.0006)	(0.0007)	(0.0007)
N	107358	107358	69612	69612	281222	281222	252174	252174
Adjusted \mathbb{R}^2	0.03	0.05	0.02	0.05	0.00	0.07	0.00	0.07
Year FE	True	True	True	True	True	True	True	True
PC FE	False	True	False	True	False	True	False	True
			1	.995-05				
Sample		Cite	JTH Cite Sim $\overline{sim_{DV}(T,j)}$			NAICS		ıclass
Spillover	•	$in MSA_T$				V(i,j)		V(i,j)
	(1)	(2)	(3)	(4)	(5)	(6)	(7)	(8)
I(MSAMatch)	0.0646***	0.0642***	0.0408***	0.0422***	0.0078***	0.0082***	0.0116***	0.0109**
	(0.0009)	(0.0009)	(0.0010)	(0.0010)	(0.0005)	(0.0005)	(0.0005)	(0.0005)
N	185154	185154	122217	122217	437685	437685	401623	401623
Adjusted R^2	0.03	0.05	0.02	0.06	0.00	0.08	0.00	0.08
Year FE	True	True	True	True	True	True	True	True
PC FE	False	True	False	True	False	True	False	True
			2	2005-15				
Sample	JTH	l Cite	JTH C	ite Sim	NA	ICS	Prim	nclass
Spillover	$pct\ cites$	$in MSA_T$	$\overline{sim_{DV}}$	$\overline{\gamma(T,j)}$	sim_D	V(i,j)	sim_D	V(i,j)
	(1)	(2)	(3)	(4)	(5)	(6)	(7)	(8)
I(MSAMatch)	0.0740***	0.0729***	0.0420***	0.0423***	0.0076***	0.0077***	0.0083***	0.0079**
	(0.0012)	(0.0012)	(0.0016)	(0.0015)	(0.0004)	(0.0004)	(0.0005)	(0.0004)
N	154619	154619	52710	52710	569252	569252	529686	529686
Adjusted \mathbb{R}^2	0.02	0.05	0.02	0.05	0.00	0.06	0.00	0.07
Year FE	True	True	True	True	True	True	True	True
PC FE	False	True	False	True	False	True	False	True

Table D.2: Regression results for general spillovers with raw data for DocVec similarity.

			1	975-85				
Sample	JTH	Cite	JTH C	ite Sim	NA	ICS	Prim	ıclass
Spillover	$pct\ cites$	$in MSA_T$	$\overline{sim_{LD}}$	$\overline{{}_{A}(T,j)}$	sim_{LD}	$o_A(i,j)$	sim_{LL}	$\rho_A(i,j)$
	(1)	(2)	(3)	(4)	(5)	(6)	(7)	(8)
I(MSAMatch)	0.2448***	0.2416***	0.0033	-0.0008	0.0465***	0.0313***	0.0566***	0.0423**
	(0.0074)	(0.0073)	(0.0139)	(0.0135)	(0.0050)	(0.0052)	(0.0057)	(0.0062)
N	58647	58647	38541	38541	193173	193173	171099	171099
Adjusted \mathbb{R}^2	0.02	0.03	0.00	0.11	0.11	0.00	0.18	0.00
Year FE	True	True	True	True	True	True	True	True
PC FE	False	True	False	True	False	True	False	True
			1	985-95				
Sample	JTH	JTH Cite		JTH Cite Sim		ICS	Primcl	
Spillover	$pct\ cites\ i$	$nMSA_T$	$\overline{sim_{LD}}$	$\overline{_A(T,j)}$	sim_{LI}	$_{\mathrm{D}A}(i,j)$	sim_{LI}	$o_A(i,j)$
	(1)	(2)	(3)	(4)	(5)	(6)	(7)	(8)
I(MSAMatch)	0.2881***	0.2846***	0.0280***	0.0057	0.0621***	0.0535***	0.0647***	0.0516**
	(0.0052)	(0.0051)	(0.0094)	(0.0091)	(0.0041)	(0.0043)	(0.0045)	(0.0050)
N	107358	107358	69612	69612	281625	281625	252478	252478
Adjusted \mathbb{R}^2	0.03	0.05	0.00	0.10	0.10	0.00	0.18	0.00
Year FE	True	True	True	True	True	True	True	True
PC FE	False	True	False	True	False	True	False	True
			1	995-05				
Sample	JTH	Cite	JTH C	ite Sim	NA	ICS	Prim	ıclass
Spillover	$pct \ cites$	$inMSA_T$	$\overline{sim_{LD}}$	A(T,j)	sim_{LL}	$o_A(i,j)$	sim_{LI}	$o_A(i,j)$
	(1)	(2)	(3)	(4)	(5)	(6)	(7)	(8)
I(MSAMatch)	0.2983***	0.2966***	0.0017	-0.0123*	0.0980***	0.0987***	0.0626***	0.0723**
	(0.0041)	(0.0041)	(0.0068)	(0.0065)	(0.0033)	(0.0035)	(0.0035)	(0.0039
N	185154	185154	122217	122217	438317	438317	402006	402006
Adjusted \mathbb{R}^2	0.03	0.05	0.00	0.11	0.12	0.00	0.20	0.00
Year FE	True	True	True	True	True	True	True	True
PC FE	False	True	False	True	False	True	False	True
			2	005-15				
Sample	JTH	Cite	JTH C	ite Sim	NA	ICS	Prim	ıclass
Spillover	pct cites	$in MSA_T$	$\overline{sim_{LD}}$	$\overline{_A(T,j)}$	sim_{LD}	$o_A(i,j)$	sim_{LL}	$o_A(i,j)$
	(1)	(2)	(3)	(4)	(5)	(6)	(7)	(8)
	0 0 4 1 7 4 4 4	0.3365***	0.0173	-0.0003	0.0804***	0.0921***	0.0433***	0.0629**
I(MSAMatch)	0.3417***	0.5505						
I(MSAMatch)	(0.0054)	(0.0054)	(0.0111)	(0.0107)	(0.0030)	(0.0032)	(0.0031)	(0.0034
,			(0.0111) 52710	(0.0107) 52710	(0.0030) 570099	570099	530245	
N	(0.0054)	(0.0054)	, ,		` ,	` ,	, ,	
$I(MSAMatch)$ N Adjusted R^2 Year FE	(0.0054) 154619	(0.0054) 154619	52710	52710	570099	570099	530245	(0.0034) 530245 0.00 True

Table D.3: Regression results for general local spillovers with normed data for LDAVec similarity.

			1	975-85				
Sample	JTH	Cite	JTH C	ite Sim	NA	ICS	Prim	ıclass
Spillover	pct cites	$in MSA_T$	$\overline{sim_{LD}}$	A(T,j)	sim_{LL}	$o_A(i,j)$	sim_{LL}	$o_A(i,j)$
	(1)	(2)	(3)	(4)	(5)	(6)	(7)	(8)
I(MSAMatch)	0.0530***	0.0523***	0.0542***	0.0534***	0.0069***	0.0103***	0.0104***	0.0139**
	(0.0016)	(0.0016)	(0.0030)	(0.0029)	(0.0012)	(0.0011)	(0.0015)	(0.0014)
N	58647	58647	38541	38541	193173	193173	171099	171099
Adjusted \mathbb{R}^2	0.02	0.03	0.01	0.12	0.00	0.11	0.00	0.18
Year FE	True	True	True	True	True	True	True	True
PC FE	False	True	False	True	False	True	False	True
			1	985-95				
Sample	JTH	Cite	JTH C	ite Sim	NA	ICS	Prim	ıclass
Spillover	pct cites	$inMSA_T$	$\overline{sim_{LD}}$	$\overline{_A(T,j)}$	sim_{LL}	$o_A(i,j)$	sim_{LL}	$o_A(i,j)$
	(1)	(2)	(3)	(4)	(5)	(6)	(7)	(8)
I(MSAMatch)	0.0624***	0.0616***	0.0570***	0.0526***	0.0119***	0.0138***	0.0126***	0.0158**
	(0.0011)	(0.0011)	(0.0020)	(0.0020)	(0.0009)	(0.0009)	(0.0012)	(0.0011
N	107358	107358	69612	69612	281625	281625	252478	252478
Adjusted \mathbb{R}^2	0.03	0.05	0.01	0.11	0.00	0.10	0.00	0.18
Year FE	True	True	True	True	True	True	True	True
PC FE	False	True	False	True	False	True	False	True
			1	995-05				
Sample	JTH	Cite	JTH C	ite Sim	NA	ICS	Prim	ıclass
Spillover	pct cites	$in MSA_T$	$\overline{sim_{LD}}$	$\overline{_A(T,j)}$	sim_{LL}	$o_A(i,j)$	sim_{LL}	$o_A(i,j)$
	(1)	(2)	(3)	(4)	(5)	(6)	(7)	(8)
I(MSAMatch)	0.0646***	0.0642***	0.0486***	0.0459***	0.0219***	0.0217***	0.0177***	0.0153**
	(0.0009)	(0.0009)	(0.0015)	(0.0014)	(8000.0)	(0.0007)	(0.0010)	(0.0009
N	185154	185154	122217	122217	438317	438317	402006	402006
Adjusted \mathbb{R}^2	0.03	0.05	0.01	0.12	0.00	0.12	0.00	0.20
Year FE	True	True	True	True	True	True	True	True
PC FE	False	True	False	True	False	True	False	True
		True	i disc					
		True		005-15				
		Cite	2		NA	ICS	Prim	ıclass
Sample Spillover	JTH		JTH C	005-15		ICS $p_A(i,j)$		oclass $o_A(i,j)$
Sample	JTH	Cite	JTH C	005-15 ite Sim				
Sample	JTH pct cites	Cite $in\ MSA_T$	$\begin{array}{c} \text{JTH C} \\ \hline sim_{LD} \end{array}$	ite Sim $_{A}(T,j)$	sim_{LL}	$o_A(i,j)$	sim_{LL}	OA(i,j) (8)
Sample Spillover	JTH pct cites (1)	Cite $in\ MSA_T$ (2)	$ \begin{array}{c} \text{JTH C} \\ \hline sim_{LD} \\ \text{(3)} \end{array} $	ite Sim $A(T,j)$ (4)	sim_{LL} (5)	$\rho_A(i,j)$ (6)	sim_{LL} (7)	OA(i, j) (8) 0.0106**
Sample Spillover $I(MSAMatch)$	JTH pct cites (1) 0.0740***	Cite in MSA _T (2) 0.0729***	JTH C sim _{LD} (3) 0.0502***	0.005-15 ite Sim $A(T,j)$ (4) 0.0468***	\$im_LI_(5) 0.0204***	0.0178***	\$im_L_I	0.0106** (0.0007
Sample Spillover $I(MSAMatch)$ N	JTH pct cites: (1) 0.0740*** (0.0012)	Cite in MSA _T (2) 0.0729*** (0.0012)	3 JTH C sim _{LD} (3) 0.0502*** (0.0024)	005-15 ite Sim A(T,j) (4) 0.0468*** (0.0023)	sim _{LL} (5) 0.0204*** (0.0007)	$O_A(i,j)$ (6) 0.0178*** (0.0007)	sim _{LL} (7) 0.0154*** (0.0008)	0.0106** (0.0007
Sample Spillover	JTH pct cites (1) 0.0740*** (0.0012) 154619	Cite (in MSA _T (2) 0.0729*** (0.0012) 154619	3) 0.0502*** (0.0024) 52710	005-15 ite Sim A(T,j) (4) 0.0468*** (0.0023) 52710	sim _{LL} (5) 0.0204*** (0.0007) 570099	0.0178*** (0.0007) 570099	sim _{LL} (7) 0.0154*** (0.0008) 530245	0.0106** 0.0007 0.0007

Table D.4: Regression results for general local spillovers with normed data for LDAVec similarity.

	1985-95			
	(1)	(2)	(3)	(4)
I(MSAMatch)	0.0054***	-0.0024***	-0.0064***	-0.0037***
	(0.0006)	(0.0006)	(0.0019)	(0.0012)
$sim_{DV}(pc_i, pc_j)$	0.1748***		0.1700***	
	(0.0017)		(0.0018)	
$sim_{DV}(pc_{i,MSA_i},pc_{j,MSA_j})$		0.0933***		0.0922***
		(0.0014)		(0.0018)
$I_{MSA} * sim_{DV}(pc_i, pc_j)$			0.0179***	
			(0.0029)	
$I_{MSA} * sim_{DV}(pc_{i,MSA_i}, pc_{j,MSA_j})$				0.0028
				(0.0025)
N	281018	227029	281018	227029
Adjusted R^2	0.11	0.09	0.11	0.09
Year FE	True	True	True	True
PC FE	True	True	True	True
	1995-05			
	(1)	(2)	(3)	(4)
I(MSAMatch)	0.0049***	-0.0031***	-0.0076***	-0.0040***
	(0.0004)	(0.0005)	(0.0015)	(0.0010)
$sim_{DV}(pc_i, pc_j)$	0.1728***		0.1678***	
	(0.0013)		(0.0015)	
$sim_{DV}(pc_{i,MSA_i},pc_{j,MSA_j})$		0.1042***		0.1034***
		(0.0011)		(0.0013)
$I_{MSA} * sim_{DV}(pc_i, pc_j)$			0.0184***	
			(0.0023)	
$I_{MSA} * sim_{DV}(pc_{i,MSA_i}, pc_{j,MSA_j})$				0.0019
				(0.0019)
N	437485	382972	437485	382972
Adjusted R^2	0.12	0.11	0.12	0.11
Year FE	True	True	True	True
PC FE	True	True	True	True
	2005-15			
	(1)	(2)	(3)	(4)
I(MSAMatch)	0.0044***	-0.0024***	-0.0091***	-0.0066***
	(0.0004)	(0.0004)	(0.0017)	(0.0011)
$sim_{DV}(pc_i, pc_j)$	0.1803***		0.1751***	
	(0.0013)		(0.0015)	
$sim_{DV}(pc_{i,MSA_i},pc_{j,MSA_j})$		0.1040***		0.1015***
		(0.0010)		(0.0012)
$I_{MSA} * sim_{DV}(pc_i, pc_j)$			0.0186***	
			(0.0024)	
$I_{MSA} * sim_{DV}(pc_{i,MSA_i}, pc_{j,MSA_j})$				0.0071***
				(0.0017)
N	569100	516531	569100	516531
Adjusted \mathbb{R}^2	0.09	0.08	0.09	0.08
Year FE	True	True	True	True
PC FE	True	True	True	True

	1985-95			
	(1)	(2)	(3)	(4)
I(MSAMatch)	0.0274***	-0.0415***	0.0280***	-0.0412***
()	(0.0038)	(0.0042)	(0.0039)	(0.0042)
$sim_{LDA}(pc_i, pc_j)$	0.4123***	, ,	0.4094***	. ,
•	(0.0023)		(0.0026)	
$sim_{LDA}(pc_{i,MSA_i}, pc_{j,MSA_j})$		0.3994***		0.4221***
		(0.0026)		(0.0031)
$I_{MSA}*sim_{LDA}(pc_i,pc_j)$			0.0114***	
			(0.0044)	
$I_{MSA} * sim_{LDA}(pc_{i,MSA_i}, pc_{j,MSA_j})$				-0.0619***
				(0.0047)
N	281421	227396	281421	227396
Adjusted \mathbb{R}^2	0.21	0.21	0.21	0.21
Year FE	True	True	True	True
PC FE	True	True	True	True
	1995-05			
	(1)	(2)	(3)	(4)
I(MSAMatch)	0.0535***	-0.0202***	0.0533***	-0.0174***
	(0.0031)	(0.0033)	(0.0031)	(0.0032)
$sim_{LDA}(pc_i, pc_j)$	0.4349***		0.4286***	
	(0.0019)		(0.0021)	
$sim_{LDA}(pc_{i,MSA_i}, pc_{j,MSA_j})$		0.4219***		0.4366***
		(0.0019)		(0.0023)
$I_{MSA} * sim_{LDA}(pc_i, pc_j)$			0.0234***	
			(0.0034)	
$I_{MSA} * sim_{LDA}(pc_{i,MSA_i}, pc_{j,MSA_j})$				-0.0417***
				(0.0035)
N	438117	383569	438117	383569
Adjusted R^2	0.24	0.24	0.24	0.25
Year FE	True	True	True	True
PC FE	True	True	True	True
	2005-15			
	(1)	(2)	(3)	(4)
I(MSAMatch)	0.0356***	-0.0279***	0.0343***	-0.0215***
	(0.0028)	(0.0029)	(0.0027)	(0.0028)
	0.4299***		0.4274***	
$sim_{LDA}(pc_i, pc_j)$	0.4299		0.4274	
$sim_{LDA}(pc_i, pc_j)$	(0.0016)		(0.0018)	
$sim_{LDA}(pc_i,pc_j)$ $sim_{LDA}(pc_{i,MSA_i},pc_{j,MSA_j})$		0.4096***		0.4197***
<u> </u>		0.4096*** (0.0016)		0.4197*** (0.0019)
<u> </u>			(0.0018) 0.0090***	
$sim_{LDA}(pc_{i,MSA_i},pc_{j,MSA_j})$ $I_{MSA}*sim_{LDA}(pc_i,pc_j)$			(0.0018)	(0.0019)
$sim_{LDA}(pc_{i,MSA_i},pc_{j,MSA_j})$			(0.0018) 0.0090***	(0.0019)
$sim_{LDA}(pc_{i,MSA_i},pc_{j,MSA_j})$ $I_{MSA}*sim_{LDA}(pc_i,pc_j)$ $I_{MSA}*sim_{LDA}(pc_{i,MSA_i},pc_{j,MSA_j})$	(0.0016)	(0.0016)	(0.0018) 0.0090*** (0.0028)	(0.0019) -0.0304*** (0.0028)
$\begin{split} sim_{LDA}(pc_{i,MSA_i},pc_{j,MSA_j}) \\ \\ I_{MSA}*sim_{LDA}(pc_{i},pc_{j}) \\ \\ I_{MSA}*sim_{LDA}(pc_{i,MSA_i},pc_{j,MSA_j}) \\ \\ N \end{split}$	(0.0016)	(0.0016) 517333	(0.0018) 0.0090*** (0.0028)	(0.0019) -0.0304*** (0.0028) 517333
$sim_{LDA}(pc_{i,MSA_i},pc_{j,MSA_j})$ $I_{MSA}*sim_{LDA}(pc_i,pc_j)$ $I_{MSA}*sim_{LDA}(pc_{i,MSA_i},pc_{j,MSA_j})$ N Adjusted R^2	(0.0016) 569947 0.26	(0.0016) 517333 0.27	(0.0018) 0.0090*** (0.0028) 569947 0.26	(0.0019) -0.0304*** (0.0028) 517333 0.27
$\begin{split} sim_{LDA}(pc_{i,MSA_i},pc_{j,MSA_j}) \\ \\ I_{MSA}*sim_{LDA}(pc_{i},pc_{j}) \\ \\ I_{MSA}*sim_{LDA}(pc_{i,MSA_i},pc_{j,MSA_j}) \\ \\ N \end{split}$	(0.0016)	(0.0016) 517333	(0.0018) 0.0090*** (0.0028)	(0.0019) -0.0304*** (0.0028) 517333

	1985-95			
	(1)	(2)	(3)	(4)
I(MSAMatch)	0.0061***	-0.0092***	0.0038***	0.0044***
(" " " " " " " " " " " " " " " " " " "	(0.0008)	(0.0009)	(0.0010)	(0.0012)
$sim_{LDA}(pc_i, pc_j)$	0.2331***	,	0.2315***	,
, J	(0.0013)		(0.0015)	
$sim_{LDA}(pc_{i,MSA_i}, pc_{j,MSA_j})$, ,	0.2509***	, ,	0.2652***
. ,		(0.0016)		(0.0020)
$I_{MSA} * sim_{LDA}(pc_i, pc_j)$			0.0064***	
			(0.0025)	
$I_{MSA} * sim_{LDA}(pc_{i,MSA_i}, pc_{j,MSA_j})$				-0.0389***
				(0.0030)
N	281421	227396	281421	227396
Adjusted \mathbb{R}^2	0.21	0.21	0.21	0.21
Year FE	True	True	True	True
PC FE	True	True	True	True
	1995-05			
	(1)	(2)	(3)	(4)
I(MSAMatch)	0.0119***	-0.0045***	0.0069***	0.0053***
	(0.0007)	(0.0007)	(0.0008)	(0.0009)
$sim_{LDA}(pc_i, pc_j)$	0.2459***		0.2423***	
	(0.0011)		(0.0012)	
$sim_{LDA}(pc_{i,MSA_i}, pc_{j,MSA_j})$		0.2651***		0.2743***
		(0.0012)		(0.0015)
$I_{MSA} * sim_{LDA}(pc_i, pc_j)$			0.0133***	
			(0.0019)	
$I_{MSA} * sim_{LDA}(pc_{i,MSA_i}, pc_{j,MSA_j})$				-0.0262***
				(0.0022)
N	438117	383569	438117	383569
Adjusted \mathbb{R}^2	0.24	0.24	0.24	0.25
Year FE	True	True	True	True
PC FE	True	True	True	True
	2005-15			
	(1)	(2)	(3)	(4)
I(MSAMatch)	0.0079***	-0.0062***	0.0057***	0.0019**
	(0.0006)	(0.0007)	(0.0007)	(8000.0)
$sim_{LDA}(pc_i, pc_j)$	0.2430***		0.2416***	
	(0.0009)		(0.0010)	
$sim_{LDA}(pc_{i,MSA_i},pc_{j,MSA_j})$		0.2573***		0.2637***
		(0.0010)		(0.0012)
$I_{MSA} * sim_{LDA}(pc_i, pc_j)$			0.0051***	
			(0.0016)	
$I_{MSA} * sim_{LDA}(pc_{i,MSA_i}, pc_{j,MSA_j})$				-0.0191***
				(0.0017)
N	569947	517333	569947	517333
Adjusted \mathbb{R}^2	0.26	0.27	0.26	0.27
,				
Year FE	True	True	True	True

Table D.7: Regression results for strict local spillovers with raw data for DocVec similarity. 59

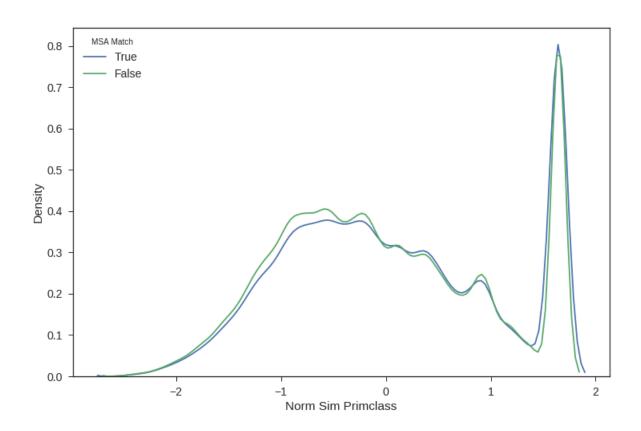


Figure D.1: Distribution of $sim(pc_i, pc_j)$ for local and non-local patent pairs.

Appl. Year	Mean Localization, Uni Patents	Std Dev, Uni Patents	Mean Localization, Other Patents	Std Dev, Other Patents	Diff	$p ext{-value}$
1975	0.004	0.027	0.005	0.037	-0.001	0.687
1976	0.001	0.046	0.005	0.040	-0.004	0.406
1977	-0.000	0.046	0.006	0.048	-0.006	0.175
1978	0.006	0.062	0.005	0.054	0.001	0.851
1979	-0.015	0.074	0.005	0.071	-0.020	0.022
1980	-0.003	0.039	0.005	0.039	-0.008	0.007
1981	0.004	0.036	0.005	0.044	-0.001	0.688
1982	0.003	0.050	0.004	0.048	-0.001	0.737
1983	-0.002	0.068	0.005	0.057	-0.007	0.185
1984	0.002	0.076	0.005	0.074	-0.002	0.704
1985	0.001	0.042	0.006	0.040	-0.004	0.095
1986	0.002	0.039	0.005	0.043	-0.003	0.160
1987	0.002	0.046	0.005	0.044	-0.003	0.210
1988	0.002	0.058	0.004	0.052	-0.002	0.595
1989	0.003	0.069	0.005	0.066	-0.002	0.676

Table E.1: Comparison of mean and standard deviation of localization effect for university vs non-university patents within the same industry by application year

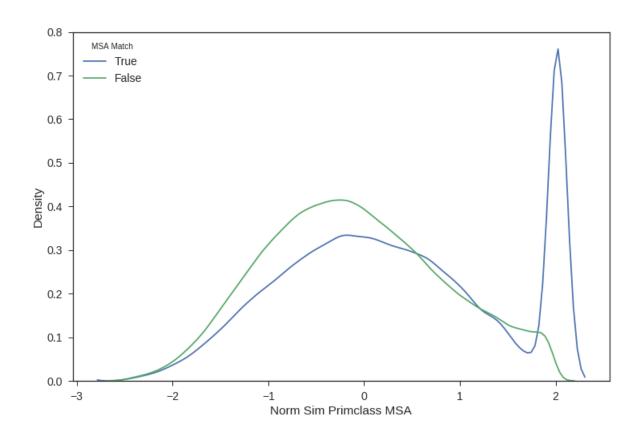


Figure D.2: Distribution of $sim(pc_i, pc_j)$ for local and non-local patent pairs.

Appl. Year	Mean Localization, Nano Patents	Std Dev, Nano Patents	Mean Localization, Other Patents	Std Dev, Other Patents	Diff	$p ext{-}value$
1990	-0.013	0.034	0.022	0.065	-0.034	0.005
1991	0.024	0.039	0.028	0.069	-0.004	0.674
1992	0.009	0.026	0.027	0.078	-0.018	0.114
1993	0.067	0.074	0.024	0.086	0.043	0.071
1994	0.020	0.086	0.024	0.106	-0.004	0.856
1995	0.007	0.058	0.022	0.062	-0.015	0.290
1996	0.008	0.041	0.019	0.065	-0.011	0.210
1997	0.016	0.048	0.023	0.073	-0.006	0.540
1998	0.017	0.060	0.022	0.086	-0.005	0.591
1999	0.012	0.086	0.023	0.111	-0.011	0.402
2000	-0.001	0.053	0.017	0.058	-0.019	0.010
2001	0.010	0.059	0.016	0.063	-0.006	0.368
2002	0.015	0.068	0.017	0.073	-0.003	0.684
2003	0.007	0.079	0.018	0.085	-0.011	0.128
2004	0.009	0.104	0.019	0.107	-0.010	0.238
2005	0.009	0.071	0.018	0.085	-0.009	0.083

Table E.2: Comparison of mean and standard deviation of localization effect for nanotechnology vs non-nanotechnology patents within the same industry by application year

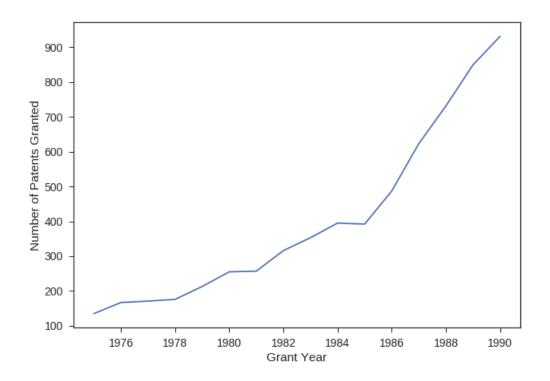


Figure E.1: Number of university patents by application year

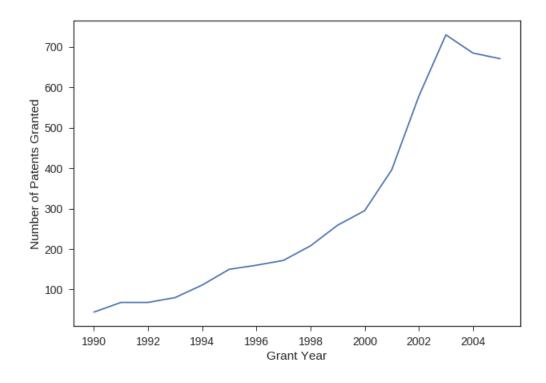


Figure E.2: Number of nanotechnology patents by application year

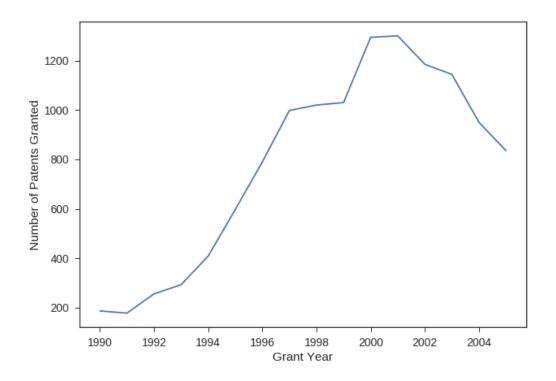


Figure E.3: Number of software patents by application year

Appl. Year	Mean Localization, Software Patents	Std Dev, Software Patents	Mean Localization, Other Patents	Std Dev, Other Patents	Diff	$p ext{-value}$
1990	0.007	0.029	0.006	0.034	0.000	0.938
1991	0.001	0.032	0.007	0.036	-0.006	0.098
1992	0.008	0.043	0.005	0.039	0.002	0.566
1993	0.001	0.044	0.003	0.043	-0.002	0.613
1994	0.006	0.051	0.006	0.056	-0.000	0.984
1995	0.004	0.027	0.006	0.032	-0.002	0.281
1996	0.006	0.029	0.005	0.033	0.002	0.271
1997	0.003	0.033	0.004	0.040	-0.001	0.355
1998	0.001	0.037	0.004	0.047	-0.003	0.092
1999	0.000	0.049	0.004	0.060	-0.003	0.194
2000	0.003	0.029	0.003	0.036	-0.001	0.613
2001	0.001	0.036	0.005	0.038	-0.004	0.004
2002	-0.002	0.038	0.003	0.043	-0.006	0.001
2003	-0.001	0.042	0.004	0.051	-0.005	0.008
2004	0.007	0.054	0.004	0.056	0.003	0.285
2005	0.006	0.043	0.002	0.046	0.003	0.140

Table E.3: Comparison of mean and standard deviation of localization effect for software vs non-software patents within the same industry by application year

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